Advanced Multibus Architecture With Three Separate 16-Bit Data Memory Buses and One Program Memory Bus
- 40-Bit Arithmetic Logic Unit (ALU), Including a 40-Bit Barrel Shifter and Two Independent 40-Bit Accumulators
- 17-×17-Bit Parallel Multiplier Coupled to a 40-Bit Dedicated Adder for Non-Pipelined Single-Cycle Multiply/Accumulate (MAC) Operation
- Compare, Select, and Store Unit (CSSU) for the Add/Compare Selection of the Viterbi Operator
- Exponent Encoder to Compute an Exponent Value of a 40-Bit Accumulator Value in a Single Cycle
- Two Address Generators With Eight Auxiliary Registers and Two Auxiliary Register Arithmetic Units (ARAUs)
- Data Bus With a Bus-Holder Feature
- Extended Addressing Mode for 1M × 16-Bit Maximum Addressable External Program Space
- 4K x 16-Bit On-Chip ROM
- 16K x 16-Bit Dual-Access On-Chip RAM
- Single-Instruction-Repeat and Block-Repeat Operations for Program Code
- Block-Memory-Move Instructions for Efficient Program and Data Management
- Instructions With a 32-Bit Long Word Operand
- Instructions With Two- or Three-Operand Reads

Arithmetic Instructions With Parallel Store and Parallel Load
- Conditional Store Instructions
- Fast Return From Interrupt
- On-Chip Peripherals
  - Software-Programmable Wait-State Generator and Programmable Bank Switching
  - On-Chip Phase-Locked Loop (PLL) Clock Generator With Internal Oscillator or External Clock Source
  - Two Multichannel Buffered Serial Ports (McBSPs)
  - Enhanced 8-Bit Parallel Host-Port Interface (HPI8)
  - Two 16-Bit Timers
  - Six-Channel Direct Memory Access (DMA) Controller
- Power Consumption Control With IDLE1, IDLE2, and IDLE3 Instructions With Power-Down Modes
- CLKOUT Off Control to Disable CLKOUT
- On-Chip Scan-Based Emulation Logic, IEEE Std 1149.1† (JTAG) Boundary Scan Logic
- 10-ns Single-Cycle Fixed-Point Instruction Execution Time (100 MIPS) for 3.3-V Power Supply (1.8-V Core)
- Available in a 144-Pin Plastic Low-Profile Quad Flatpack (LQFP) (PGE Suffix) and a 144-Pin Ball Grid Array (BGA) (GGU Suffix)

NOTE: This data sheet is designed to be used in conjunction with the TMS320C5000 DSP Family Functional Overview (literature number SPRU307).

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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REVISION HISTORY

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<td>August 2000</td>
<td>Production Data</td>
<td>Added Table of Contents, Revision History, and corrected IDLE3 current on page 35.</td>
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<td>F</td>
<td>February 2005</td>
<td>Production Data</td>
<td>Updated table of contents and revision history. Added notices concerning JTAG (IEEE 1149.1) boundary scan test capability and replaced document support section on page 33. Added device and development-support tool nomenclature section on page 34. Replaced Figure 9 on page 37. Replaced Figure 36 on page 65. Replaced mechanical section on page 66.</td>
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| G        | October 2008 | Production Data | Terminal Functions table:  
− Updated DESCRIPTION of TRST  
− Added footnote about TRST  
Mechanical Data section:  
− Revised paragraph  
− Mechanical drawings will be appended to this document via an automated process |
**Description**

The TMS320VC5402 fixed-point, digital signal processor (DSP) (hereafter referred to as the 5402 unless otherwise specified) is based on an advanced modified Harvard architecture that has one program memory bus and three data memory buses. This processor provides an arithmetic logic unit (ALU) with a high degree of parallelism, application-specific hardware logic, on-chip memory, and additional on-chip peripherals. The basis of the operational flexibility and speed of this DSP is a highly specialized instruction set.

Separate program and data spaces allow simultaneous access to program instructions and data, providing the high degree of parallelism. Two read operations and one write operation can be performed in a single cycle. Instructions with parallel store and application-specific instructions can fully utilize this architecture. In addition, data can be transferred between data and program spaces. Such parallelism supports a powerful set of arithmetic, logic, and bit-manipulation operations that can be performed in a single machine cycle. In addition, the 5402 includes the control mechanisms to manage interrupts, repeated operations, and function calls.
The TMS320VC5402PGE (144-pin LQFP) package is footprint-compatible with the 'LC548, 'LC/VC549, and 'VC5410 devices.
The pin assignments table to follow lists each signal quadrant and BGA ball number for the TMS320VC5402GGU (144-pin BGA) package which is footprint-compatible with the 'LC548 and 'LC/VC549 devices.
<table>
<thead>
<tr>
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<th>BGA BALL #</th>
<th>SIGNAL NAME</th>
<th>BGA BALL #</th>
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<td>M12</td>
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† DVDD is the power supply for the I/O pins while CVDD is the power supply for the core CPU. VSS is the ground for both the I/O pins and the core CPU.
terminal functions

The following table lists each signal, function, and operating mode(s) grouped by function.

### Terminal Functions

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<th>TERMINAL NAME</th>
<th>TYPE†</th>
<th>DESCRIPTION</th>
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<tbody>
<tr>
<td><strong>DATA SIGNALS</strong></td>
<td></td>
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<tr>
<td>A19 (MSB)</td>
<td>O/Z</td>
<td>Parallel address bus A19 [most significant bit (MSB)] through A0 [least significant bit (LSB)]. The lower sixteen address pins (A0 to A15) are multiplexed to address all external memory (program, data) or I/O, while the upper four address pins (A16 to A19) are only used to address external program space. These pins are placed in the high-impedance state when the hold mode is enabled, or when OFF is low.</td>
</tr>
<tr>
<td>A18</td>
<td></td>
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<td>A17</td>
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<td>A16</td>
<td></td>
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<td>A0 (LSB)</td>
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<tr>
<td><strong>D15 (MSB)</strong></td>
<td>I/O/Z</td>
<td>Parallel data bus D15 (MSB) through D0 (LSB). The sixteen data pins (D0 to D15) are multiplexed to transfer data between the core CPU and external data/program memory or I/O devices. The data bus is placed in the high-impedance state when not outputting or when RS or HOLD is asserted. The data bus also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>D14</td>
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<tr>
<td>D13</td>
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<td>D12</td>
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<tr>
<td>D0 (LSB)</td>
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<tr>
<td><strong>INITIALIZATION, INTERRUPT, AND RESET OPERATIONS</strong></td>
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<tr>
<td>IACK</td>
<td>O/Z</td>
<td>Interrupt acknowledge signal. IACK indicates receipt of an interrupt and that the program counter is fetching the interrupt vector location designated by A15–A0. IACK also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>INT0</td>
<td></td>
<td></td>
</tr>
<tr>
<td>INT1</td>
<td>I</td>
<td>External user interrupts. INT0–INT3 are prioritized and are maskable by the interrupt mask register (IMR) and the interrupt mode bit. INT0–INT3 can be polled and reset by way of the interrupt flag register (IFR).</td>
</tr>
<tr>
<td>INT2</td>
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<tr>
<td>INT3</td>
<td></td>
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</tr>
<tr>
<td>NMI</td>
<td>I</td>
<td>Nonmaskable interrupt. NMI is an external interrupt that cannot be masked by way of the INTM or the IMR. When NMI is activated, the processor traps to the appropriate vector location.</td>
</tr>
</tbody>
</table>

† I = input, O = output, Z = high impedance, S = supply
‡ All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVDD), rather than the 3V I/O supply (DVDD). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
§ Although this pin includes an internal pulldown resistor, a 470-Ω external pulldown is required. If the TRST pin is connected to multiple DSPs, a buffer is recommended to ensure the VIL and VIH specifications are met.
### Terminal Functions (Continued)

<table>
<thead>
<tr>
<th>TERMINAL NAME</th>
<th>TYPE†</th>
<th>DESCRIPTION</th>
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<td><strong>INTIALIZATION, INTERRUPT, AND RESET OPERATIONS (CONTINUED)</strong></td>
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</tr>
<tr>
<td>RS</td>
<td>I</td>
<td>Reset. RS causes the digital signal processor (DSP) to terminate execution and causes a reinitialization of the CPU and peripherals. When RS is brought to a high level, execution begins at location 0FF80h of program memory. RS affects various registers and status bits.</td>
</tr>
<tr>
<td>MP/MC</td>
<td>I</td>
<td>Microprocessor/microcomputer mode select. If active low at reset, microcomputer mode is selected, and the internal program ROM is mapped into the upper 4K words of program memory space. If the pin is driven high during reset, microprocessor mode is selected, and the on-chip ROM is removed from program space. This pin is only sampled at reset, and the MP/MC bit of the processor mode status (PMST) register can override the mode that is selected at reset.</td>
</tr>
</tbody>
</table>

### MULTIPROCESSING SIGNALS

| BIO           | I     | Branch control. A branch can be conditionally executed when BIO is active. If low, the processor executes the conditional instruction. For the XC instruction, the BIO condition is sampled during the decode phase of the pipeline; all other instructions sample BIO during the read phase of the pipeline. |
| XF            | O/Z   | External flag output (latched software-programmable signal). XF is set high by the SSBX XF instruction, set low by the RSBX XF instruction or by loading ST1. XF is used for signaling other processors in multiprocessor configurations or used as a general-purpose output pin. XF goes into the high-impedance state when OFF is low, and is set high at reset. |

### MEMORY CONTROL SIGNALS

| DS            | O/Z   | Data, program, and I/O space select signals. DS, PS, and IS are always high unless driven low for accessing a particular external memory space. Active period corresponds to valid address information. DS, PS, and IS are placed into the high-impedance state in the hold mode; the signals also go into the high-impedance state when OFF is low. |
| PS            | O/Z   | Memory strobe signal. MSTRB is always high unless low-level asserted to indicate an external bus access to data or program memory. MSTRB is placed in the high-impedance state in the hold mode; it also goes into the high-impedance state when OFF is low. |
| IS            | O/Z   | Data ready. READY indicates that an external device is prepared for a bus transaction to be completed. If the device is not ready (READY is low), the processor waits one cycle and checks READY again. Note that the processor performs ready detection if at least two software wait states are programmed. The READY signal is not sampled until the completion of the software wait states. |
| MSTRB         | O/Z   | Read/write signal. R/W indicates transfer direction during communication to an external device. R/W is normally in the read mode (high), unless it is asserted low when the DSP performs a write operation. R/W is placed in the high-impedance state in hold mode; it also goes into the high-impedance state when OFF is low. |
| IOSTR B       | O/Z   | I/O strobe signal. IOSTR B is always high unless low-level asserted to indicate an external bus access to an I/O device. IOSTR B is placed in the high-impedance state in the hold mode; it also goes into the high-impedance state when OFF is low. |
| HOLD          | I     | Hold. HOLD is asserted to request control of the address, data, and control lines. When acknowledged by the C54x, these lines go into the high-impedance state. |
| HOLDA         | O/Z   | Hold acknowledge. HOLDA indicates that the 5402 is in a hold state and that the address, data, and control lines are in the high-impedance state, allowing the external memory interface to be accessed by other devices. HOLDA also goes into the high-impedance state when OFF is low. |

† I = input, O = output, Z = high impedance, S = supply
‡ All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVDD), rather than the 3V I/O supply (DVDD). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
§ Although this pin includes an internal pulldown resistor, a 470-Ω external pulldown is required. If the TRST pin is connected to multiple DSPs, a buffer is recommended to ensure the VIH and VIL specifications are met.
## Terminal Functions (Continued)

<table>
<thead>
<tr>
<th>TERMINAL NAME</th>
<th>TYPE†</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>MEMORY CONTROL SIGNALS (CONTINUED)</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>MSC</td>
<td>O/Z</td>
<td>Microstate complete. MSC indicates completion of all software wait states. When two or more software wait states are enabled, the MSC pin goes active at the beginning of the first software wait state and goes inactive high at the beginning of the last software wait state. If connected to the READY input, MSC forces one external wait state after the last internal wait state is completed. MSC also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>IAQ</td>
<td>O/Z</td>
<td>Instruction acquisition signal. IAQ is asserted (active low) when there is an instruction address on the address bus. IAQ goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td><strong>OSCILLATOR/TIMER SIGNALS</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>CLKOUT</td>
<td>O/Z</td>
<td>Master clock output signal. CLKOUT cycles at the machine-cycle rate of the CPU. The internal machine cycle is bounded by rising edges of this signal. CLKOUT also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>CLKMD1</td>
<td></td>
<td>Clock mode select signals. These inputs select the mode that the clock generator is initialized to after reset. The logic levels of CLKMD1–CLKMD3 are latched when the reset pin is low, and the clock mode register is initialized to the selected mode. After reset, the clock mode can be changed through software, but the clock mode select signals have no effect until the device is reset again.</td>
</tr>
<tr>
<td>CLKMD2</td>
<td></td>
<td></td>
</tr>
<tr>
<td>CLKMD3</td>
<td></td>
<td></td>
</tr>
<tr>
<td>X2/CLKIN</td>
<td>I</td>
<td>Oscillator input. This is the input to the on-chip oscillator.</td>
</tr>
<tr>
<td>X1</td>
<td>O</td>
<td>Output pin from the internal oscillator for the crystal.</td>
</tr>
<tr>
<td></td>
<td></td>
<td>If the internal oscillator is not used, X2/CLKIN functions as the clock input, and can be driven by an external clock source.‡</td>
</tr>
<tr>
<td>TOUT0</td>
<td>O/Z</td>
<td>Timer0 output. TOUT0 signals a pulse when the on-chip timer 0 counts down past zero. The pulse is a CLKOUT cycle wide. TOUT0 also goes into the high-impedance state when OFF is low.‡</td>
</tr>
<tr>
<td>TOUT1</td>
<td>O/Z</td>
<td>Timer1 output. TOUT1 signals a pulse when the on-chip timer1 counts down past zero. The pulse is one CLKOUT cycle wide. The TOUT1 output is multiplexed with the HINT pin of the HPI and is only available when the HPI is disabled. TOUT1 also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td><strong>MULTICHLANNE SERIAL PORT SIGNALS</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>BCLKR0</td>
<td>I/O/Z</td>
<td>Receive clock input. BCLKR can be configured as an input or an output; it is configured as an input following reset. BCLKR serves as the serial shift clock for the buffered serial port receiver.</td>
</tr>
<tr>
<td>BCLKR1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BDR0</td>
<td>I/O</td>
<td>Serial data receive input</td>
</tr>
<tr>
<td>BDR1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BFSR0</td>
<td>I/O/Z</td>
<td>Frame synchronization pulse for receive input. BFSR can be configured as an input or an output; it is configured as an input following reset. The BFSR pulse initiates the receive data process over BDR.</td>
</tr>
<tr>
<td>BFSR1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BCLKX0</td>
<td>I/O/Z</td>
<td>Transmit clock. BCLKX serves as the serial shift clock for the McBSP transmitter. BCLKX can be configured as an input or an output; it is configured as an input following reset. BCLKX enters the high-impedance state when OFF goes low.</td>
</tr>
<tr>
<td>BCLKX1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BDX0</td>
<td>O/Z</td>
<td>Serial data transmit output. BDX is placed in the high-impedance state when not transmitting, when HS is asserted, or when OFF is low.</td>
</tr>
<tr>
<td>BDX1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BFSX0</td>
<td>I/O/Z</td>
<td>Frame synchronization pulse for transmit input/output. The BFSX pulse initiates the transmit data process. BFSX can be configured as an input or an output; it is configured as an input following reset. BFSX goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>BFSX1</td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>MISCELLANEOUS SIGNAL</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>NC</td>
<td>No connection</td>
<td></td>
</tr>
</tbody>
</table>

† I = input, O = output, Z = high impedance, S = supply
‡ All revisions of the S402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVDD), rather than the 3V I/O supply (DVDD). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
§ Although this pin includes an internal pulldown resistor, a 470-Ω external pulldown is required. If the TRST pin is connected to multiple DSPs, a buffer is recommended to ensure the VINL and VINH specifications are met.
## Terminal Functions (Continued)

<table>
<thead>
<tr>
<th>TERMINAL NAME</th>
<th>TYPE†</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>HOST-PORT INTERFACE SIGNALS</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>HD0−HD7</td>
<td>I/O/Z</td>
<td>Parallel bidirectional data bus. The HPI data bus is used by a host device to exchange information with the HPI registers. These pins can also be used as general-purpose I/O pins. HD0−HD7 is placed in the high-impedance state when not outputting data or when OFF is low. The HPI data bus includes bus holders to reduce the static power dissipation caused by floating, unused pins. When the HPI data bus is not being driven by the 5402, the bus holders keep the pins at the previous logic level. The HPI data bus holders are disabled at reset and can be enabled/disabled via the HBH bit of the BSCR.</td>
</tr>
<tr>
<td>HCNTL0, HCNTL1</td>
<td>I</td>
<td>Control. HCNTL0 and HCNTL1 select a host access to one of the three HPI registers. The control inputs have internal pullup resistors that are only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HBIL</td>
<td>I</td>
<td>Byte identification. HBIL identifies the first or second byte of transfer. The HBIL input has an internal pullup resistor that is only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HCS</td>
<td>I</td>
<td>Chip select. HCS is the select input for the HPI and must be driven low during accesses. The chip-select input has an internal pullup resistor that is only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HDST1, HDST2</td>
<td>I</td>
<td>Data strobe. HDST1 and HDST2 are driven by the host read and write strobes to control transfers. The strobe inputs have internal pullup resistors that are only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HAS</td>
<td>I</td>
<td>Address strobe. Hosts with multiplexed address and data pins require HAS to latch the address in the HPIA register. HAS has an internal pullup resistor that is only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HR/W</td>
<td>I</td>
<td>Read/write. HR/W controls the direction of an HPI transfer. R/W has an internal pullup resistor that is only enabled when HPIENA = 0.</td>
</tr>
<tr>
<td>HRDY</td>
<td>O/Z</td>
<td>Ready. The ready output informs the host when the HPI is ready for the next transfer. HRDY goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>HINT</td>
<td>O/Z</td>
<td>Host interrupt. This output is used to interrupt the host. When the DSP is in reset, HINT is driven high. HINT can also be configured as the timer 1 output (TOUT1), when the HPI is disabled. The signal goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>HPIENA</td>
<td>I</td>
<td>HPI module select. HPIENA must be driven high during reset to enable the HPI. An internal pulldown resistor is always active and the HPIENA pin is sampled on the rising edge of RS. If HPIENA is left open or is driven low during reset, the HPI module is disabled. Once the HPI is disabled, the HPIENA pin has no effect until the 5402 is reset.</td>
</tr>
<tr>
<td><strong>SUPPLY PINS</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>CVDD</td>
<td>S</td>
<td>+VDD: Dedicated 1.8-V power supply for the core CPU</td>
</tr>
<tr>
<td>DVDD</td>
<td>S</td>
<td>+VDD: Dedicated 3.3-V power supply for the I/O pins</td>
</tr>
<tr>
<td>VSS</td>
<td>S</td>
<td>Ground</td>
</tr>
<tr>
<td><strong>TEST PINS</strong></td>
<td></td>
<td></td>
</tr>
<tr>
<td>TCK</td>
<td>I</td>
<td>IEEE standard 1149.1 test clock. TCK is normally a free-running clock signal with a 50% duty cycle. The changes on the test access port (TAP) of input signals TMS and TDI are clocked into the TAP controller, instruction register, or selected test data register on the rising edge of TCK. Changes at the TAP output signal (TDO) occur on the falling edge of TCK.</td>
</tr>
<tr>
<td>TDI</td>
<td>I</td>
<td>IEEE standard 1149.1 test data input pin with internal pullup device. TDI is clocked into the selected register (instruction or data) on a rising edge of TCK.</td>
</tr>
<tr>
<td>TDO</td>
<td>O/Z</td>
<td>IEEE standard 1149.1 test data output. The contents of the selected register (instruction or data) are shifted out of TDO on the falling edge of TCK. TDO is in the high-impedance state except when the scanning of data is in progress. TDO also goes into the high-impedance state when OFF is low.</td>
</tr>
<tr>
<td>TMS</td>
<td>I</td>
<td>IEEE standard 1149.1 test mode select. Pin with internal pullup device. This serial control input is clocked into the TAP controller on the rising edge of TCK.</td>
</tr>
</tbody>
</table>

† I = input, O = output, Z = high impedance, S = supply
‡ All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVDD), rather than the 3V I/O supply (DVDD). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
§ Although this pin includes an internal pulldown resistor, a 470-Ω external pulldown is required. If the TRST pin is connected to multiple DSPs, a buffer is recommended to ensure the VIL and VIH specifications are met.
### Terminal Functions (Continued)

<table>
<thead>
<tr>
<th>TERMINAL NAME</th>
<th>TYPE†</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>TRST§</td>
<td>I</td>
<td>IEEE standard 1149.1 test reset. TRST, when high, gives the IEEE standard 1149.1 scan system control of the operations of the device. If TRST is driven low, the device operates in its functional mode, and the IEEE standard 1149.1 signals are ignored. Pin with internal pulldown device.</td>
</tr>
<tr>
<td>EMU0</td>
<td>I/O/Z</td>
<td>Emulator 0 pin. When TRST is driven low, EMU0 must be high for activation of the OFF condition. When TRST is driven high, EMU0 is used as an interrupt to or from the emulator system and is defined as input/output by way of the IEEE standard 1149.1 scan system.</td>
</tr>
<tr>
<td>EMU1/OFF</td>
<td>I/O/Z</td>
<td>Emulator 1 pin/disable all outputs. When TRST is driven high, EMU1/OFF is used as an interrupt to or from the emulator system and is defined as input/output by way of the IEEE standard 1149.1 scan system. When TRST is driven low, EMU1/OFF is configured as OFF. The EMU1/OFF signal, when active low, puts all output drivers into the high-impedance state. Note that OFF is used exclusively for testing and emulation purposes (not for multiprocessing applications). The OFF feature is selected by the following pin combinations: TRST = low, EMU0 = high, EMU1/OFF = low.</td>
</tr>
</tbody>
</table>

† I = input, O = output, Z = high impedance, S = supply
‡ All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVDD), rather than the 3V I/O supply (DVDD). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
§ Although this pin includes an internal pulldown resistor, a 470-Ω external pulldown is required. If the TRST pin is connected to multiple DSPs, a buffer is recommended to ensure the VIL and VIH specifications are met.
memory

The 5402 device provides both on-chip ROM and RAM memories to aid in system performance and integration.

on-chip ROM with bootloader

The 5402 features a 4K-word \( \times \) 16-bit on-chip maskable ROM. Customers can arrange to have the ROM of the 5402 programmed with contents unique to any particular application. A security option is available to protect a custom ROM. This security option is described in the *TMS320C54x DSP CPU and Peripherals Reference Set, Volume 1* (literature number SPRU131). Note that only the ROM security option, and not the ROM/RAM option, is available on the 5402.

A bootloader is available in the standard 5402 on-chip ROM. This bootloader can be used to automatically transfer user code from an external source to anywhere in the program memory at power up. If the MP/MC pin is sampled low during a hardware reset, execution begins at location FF80h of the on-chip ROM. This location contains a branch instruction to the start of the bootloader program. The standard 5402 bootloader provides different ways to download the code to accommodate various system requirements:

- Parallel from 8-bit or 16-bit-wide EPROM
- Parallel from I/O space 8-bit or 16-bit mode
- Serial boot from serial ports 8-bit or 16-bit mode
- Host-port interface boot

The standard on-chip ROM layout is shown in Table 1.

### Table 1. Standard On-Chip ROM Layout†

<table>
<thead>
<tr>
<th>ADDRESS RANGE</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>F000h – F7FFh</td>
<td>Reserved</td>
</tr>
<tr>
<td>F800h – FBFFh</td>
<td>Bootloader</td>
</tr>
<tr>
<td>FC00h – FCFFh</td>
<td>( \mu )-law expansion table</td>
</tr>
<tr>
<td>FD00h – FDFFh</td>
<td>( A )-law expansion table</td>
</tr>
<tr>
<td>FE00h – FEFFh</td>
<td>Sine look-up table</td>
</tr>
<tr>
<td>FF00h – FF7Fh</td>
<td>Reserved</td>
</tr>
<tr>
<td>FF80h – FFFFh</td>
<td>Interrupt vector table</td>
</tr>
</tbody>
</table>

† In the ‘VC5402 ROM, 128 words are reserved for factory device-testing purposes. Application code to be implemented in on-chip ROM must reserve these 128 words at addresses FF00h–FF7Fh in program space.

on-chip RAM

The 5402 device contains 16K \( \times \) 16-bit of on-chip dual-access RAM (DARAM). The DARAM is composed of two blocks of 8K words each. Each block in the DARAM can support two reads in one cycle, or a read and a write in one cycle. The DARAM is located in the address range 0060h–3FFFh in data space, and can be mapped into program/data space by setting the OVLY bit to one.
**memory map**

**Figure 1. Memory Map**

**relocatable interrupt vector table**

The reset, interrupt, and trap vectors are addressed in program space. These vectors are soft — meaning that the processor, when taking the trap, loads the program counter (PC) with the trap address and executes the code at the vector location. Four words are reserved at each vector location to accommodate a delayed branch instruction, either two 1-word instructions or one 2-word instruction, which allows branching to the appropriate interrupt service routine with minimal overhead.

At device reset, the reset, interrupt, and trap vectors are mapped to address FF80h in program space. However, these vectors can be remapped to the beginning of any 128-word page in program space after device reset. This is done by loading the interrupt vector pointer (IPTR) bits in the PMST register (see Figure 2) with the appropriate 128-word page boundary address. After loading IPTR, any user interrupt or trap vector is mapped to the new 128-word page.

**NOTE:** The hardware reset (RS) vector cannot be remapped because a hardware reset loads the IPTR with 1s. Therefore, the reset vector is always fetched at location FF80h in program space.
relocatable interrupt vector table (continued)

<table>
<thead>
<tr>
<th>15</th>
<th>14</th>
<th>13</th>
<th>12</th>
<th>11</th>
<th>10</th>
<th>9</th>
<th>8</th>
<th>7</th>
<th>6</th>
<th>5</th>
<th>4</th>
<th>3</th>
<th>2</th>
<th>1</th>
<th>0</th>
</tr>
</thead>
<tbody>
<tr>
<td>IPTR</td>
<td>MP/MC</td>
<td>OVL</td>
<td>AVIS</td>
<td>DROM</td>
<td>CLK</td>
<td>OFF</td>
<td>SMUL</td>
<td>SST</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>R/W</td>
<td>R/W</td>
<td>R/W</td>
<td>R</td>
<td>R</td>
<td>R</td>
<td>R/W</td>
<td>R/W</td>
<td>R/W</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

**LEGEND:** R = Read, W = Write

**Figure 2. Processor Mode Status (PMST) Registers**

**extended program memory**

The 5402 uses a paged extended memory scheme in program space to allow access of up to 1024K program memory locations. In order to implement this scheme, the 5402 includes several features that are also present on the 548/549 devices:

- Twenty address lines, instead of sixteen
- An extra memory-mapped register, the XPC register, defines the page selection. This register is memory-mapped into data space to address 001Eh. At a hardware reset, the XPC is initialized to 0.
- Six extra instructions for addressing extended program space. These six instructions affect the XPC:
  - \( FB[D] \) pmad (20 bits) – Far branch
  - \( FBACC[D] \) Accu[19:0] – Far branch to the location specified by the value in accumulator A or accumulator B
  - \( FCALL[D] \) pmad (20 bits) – Far call
  - \( FCALA[D] \) Accu[19:0] – Far call to the location specified by the value in accumulator A or accumulator B
  - \( FRET[D] \) – Far return
  - \( FRETE[D] \) – Far return with interrupts enabled
- In addition to these new instructions, two 54x instructions are extended to use 20 bits in the 5402:
  - \( READA \) data_memory (using 20-bit accumulator address)
  - \( WRITA \) data_memory (using 20-bit accumulator address)

All other instructions, software interrupts and hardware interrupts do not modify the XPC register and access only memory within the current page.

Program memory in the 5402 is organized into 16 pages that are each 64K in length, as shown in Figure 3.
extended program memory (continued)

<table>
<thead>
<tr>
<th>Page</th>
<th>Lower 16K</th>
<th>Page</th>
<th>Lower 16K</th>
<th>...</th>
<th>Page</th>
<th>Lower 16K</th>
</tr>
</thead>
<tbody>
<tr>
<td>0000</td>
<td>External</td>
<td>10000</td>
<td>External</td>
<td></td>
<td>F0000</td>
<td>External</td>
</tr>
<tr>
<td>13FF</td>
<td></td>
<td>20000</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>14000</td>
<td></td>
<td>23FFF</td>
<td></td>
<td></td>
<td>F3FFF</td>
<td></td>
</tr>
<tr>
<td>0FFFF</td>
<td>64K Words</td>
<td>1FFFF</td>
<td></td>
<td></td>
<td>F4000</td>
<td></td>
</tr>
<tr>
<td>2FFFF</td>
<td></td>
<td>...</td>
<td>2FFFF</td>
<td></td>
<td>FFFFF</td>
<td></td>
</tr>
</tbody>
</table>

† See Figure 1
‡ The lower 16K words of pages 1 through 15 are available only when the OVLY bit is cleared to 0. If the OVLY bit is set to 1, the on-chip RAM is mapped to the lower 16K words of all program space pages.

**Figure 3. Extended Program Memory**
on-chip peripherals

The 5402 device has the following peripherals:

- Software-programmable wait-state generator with programmable bank-switching wait states
- An enhanced 8-bit host-port interface (HPI8)
- Two multichannel buffered serial ports (McBSPs)
- Two hardware timers
- A clock generator with a phase-locked loop (PLL)
- A direct memory access (DMA) controller

software-programmable wait-state generator

The software wait-state generator of the 5402 can extend external bus cycles by up to fourteen machine cycles. Devices that require more than fourteen wait states can be interfaced using the hardware READY line. When all external accesses are configured for zero wait states, the internal clocks to the wait-state generator are automatically disabled. Disabling the wait-state generator clocks reduces the power consumption of the 5402.

The software wait-state register (SWWSR) controls the operation of the wait-state generator. The 14 LSBs of the SWWSR specify the number of wait states (0 to 7) to be inserted for external memory accesses to five separate address ranges. This allows a different number of wait states for each of the five address ranges. Additionally, the software wait-state multiplier (SWSM) bit of the software wait-state control register (SWCR) defines a multiplication factor of 1 or 2 for the number of wait states. At reset, the wait-state generator is initialized to provide seven wait states on all external memory accesses. The SWWSR bit fields are shown in Figure 4 and described in Table 2.

```
15  14  12  11  9   8   6   5   3   2   0
XPA | I/O | Data | Data | Program | Program
R/W-0 | R/W-111 | R/W-111 | R/W-111 | R/W-111 | R/W-111
```

LEGEND: R=Read, W=Write, 0=Value after reset

Figure 4. Software Wait-State Register (SWWSR) [Memory-Mapped Register (MMR) Address 0028h]
software-programmable wait-state generator (continued)

Table 2. Software Wait-State Register (SWWSR) Bit Fields

<table>
<thead>
<tr>
<th>BIT NO.</th>
<th>NAME</th>
<th>RESET VALUE</th>
<th>FUNCTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15</td>
<td>XPA</td>
<td>0</td>
<td>Extended program address control bit. XPA is used in conjunction with the program space fields (bits 0 through 5) to select the address range for program space wait states.</td>
</tr>
<tr>
<td>14−12</td>
<td>I/O</td>
<td>1</td>
<td>I/O space. The field value (0−7) corresponds to the base number of wait states for I/O space accesses within addresses 0000−FFFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.</td>
</tr>
<tr>
<td>11−9</td>
<td>Data</td>
<td>1</td>
<td>Upper data space. The field value (0−7) corresponds to the base number of wait states for external data space accesses within addresses 8000−FFFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.</td>
</tr>
<tr>
<td>8−6</td>
<td>Data</td>
<td>1</td>
<td>Lower data space. The field value (0−7) corresponds to the base number of wait states for external data space accesses within addresses 0000−7FFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.</td>
</tr>
<tr>
<td>5−3</td>
<td>Program</td>
<td>1</td>
<td>Upper program space. The field value (0−7) corresponds to the base number of wait states for external program space accesses within the following addresses:</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>XPA = 0: x8000 − xFFFFh</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>XPA = 1: The upper program space bit field has no effect on wait states.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.</td>
</tr>
<tr>
<td>2−0</td>
<td>Program</td>
<td>1</td>
<td>Program space. The field value (0−7) corresponds to the base number of wait states for external program space accesses within the following addresses:</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>XPA = 0: x0000 − x7FFFh</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>XPA = 1: 00000 − FFFFh</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.</td>
</tr>
</tbody>
</table>

The software wait-state multiplier bit of the software wait-state control register (SWCR) is used to extend the base number of wait states selected by the SWWSR. The SWCR bit fields are shown in Figure 5 and described in Table 3.

![Figure 5. Software Wait-State Control Register (SWCR) [MMR Address 002Bh]](image)

Table 3. Software Wait-State Control Register (SWCR) Bit Fields

<table>
<thead>
<tr>
<th>PIN NO.</th>
<th>NAME</th>
<th>RESET VALUE</th>
<th>FUNCTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15–1</td>
<td>Reserved</td>
<td>0</td>
<td>These bits are reserved and are unaffected by writes.</td>
</tr>
<tr>
<td>0</td>
<td>SWSM</td>
<td>0</td>
<td>Software wait-state multiplier. Used to multiply the number of wait states defined in the SWWSR by a factor of 1 or 2.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>SWSM = 0: wait-state base values are unchanged (multiplied by 1).</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>SWSM = 1: wait-state base values are multiplied by 2 for a maximum of 14 wait states.</td>
</tr>
</tbody>
</table>
programmable bank-switching wait states

The programmable bank-switching logic of the 5402 is functionally equivalent to that of the 548/549 devices. This feature automatically inserts one cycle when accesses cross memory-bank boundaries within program or data memory space. A bank-switching wait state can also be automatically inserted when accesses cross the data space boundary into program space.

The bank-switching control register (BSCR) defines the bank size for bank-switching wait states. Figure 6 shows the BSCR and its bits are described in Table 4.

Table 4. Bank-Switching Control Register (BSCR) Fields

<table>
<thead>
<tr>
<th>BIT NO.</th>
<th>NAME</th>
<th>RESET VALUE</th>
<th>FUNCTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15−12</td>
<td>BNKCMP</td>
<td>1111</td>
<td>Bank compare. Determines the external memory-bank size. BNKCMP is used to mask the four MSBs of an address. For example, if BNKCMP = 1111b, the four MSBs (bits 12−15) are compared, resulting in a bank size of 4K words. Bank sizes of 4K words to 64K words are allowed.</td>
</tr>
<tr>
<td>11</td>
<td>PS−DS</td>
<td>1</td>
<td>Program read – data read access. Inserts an extra cycle between consecutive accesses of program read and data read or data read and program read. PS−DS = 0 No extra cycles are inserted by this feature. PS−DS = 1 One extra cycle is inserted between consecutive data and program reads.</td>
</tr>
<tr>
<td>10−3</td>
<td>Reserved</td>
<td>0</td>
<td>These bits are reserved and are unaffected by writes.</td>
</tr>
<tr>
<td>2</td>
<td>HBH</td>
<td>0</td>
<td>HPI Bus holder. Controls the HPI bus holder feature. HBH is cleared to 0 at reset. HBH = 0 The bus holder is disabled. HBH = 1 The bus holder is enabled. When not driven, the HPI data bus (HD[7:0]) is held in the previous logic level.</td>
</tr>
<tr>
<td>1</td>
<td>BH</td>
<td>0</td>
<td>Bus holder. Controls the data bus holder feature. BH is cleared to 0 at reset. BH = 0 The bus holder is disabled. BH = 1 The bus holder is enabled. When not driven, the data bus (D[15:0]) is held in the previous logic level.</td>
</tr>
<tr>
<td>0</td>
<td>EXIO</td>
<td>0</td>
<td>External bus interface off. The EXIO bit controls the external bus-off function. EXIO = 0 The external bus interface functions as usual. EXIO = 1 The address bus, data bus, and control signals become inactive after completing the current bus cycle. Note that the DROM, MP/MC, and OVLY bits in the PMST and the HM bit of ST1 cannot be modified when the interface is disabled.</td>
</tr>
</tbody>
</table>
parallel I/O ports

The 5402 has a total of 64K I/O ports. These ports can be addressed by the PORTR instruction or the PORTW instruction. The IS signal indicates a read/write operation through an I/O port. The 5402 can interface easily with external devices through the I/O ports while requiring minimal off-chip address-decoding circuits.

enhanced 8-bit host-port interface

The 5402 host-port interface, also referred to as the HPI8, is an enhanced version of the standard 8-bit HPI found on earlier 54x DSPs (542, 545, 548, and 549). The HPI8 is an 8-bit parallel port for interprocessor communication. The features of the HPI8 include:

Standard features:
- Sequential transfers (with autoincrement) or random-access transfers
- Host interrupt and 54x interrupt capability
- Multiple data strobes and control pins for interface flexibility

Enhanced features of the 5402 HPI8:
- Access to entire on-chip RAM through DMA bus
- Capability to continue transferring during emulation stop

The HPI8 functions as a slave and enables the host processor to access the on-chip memory of the 5402. A major enhancement to the 5402 HPI over previous versions is that it allows host access to the entire on-chip memory range of the DSP. The HPI8 memory map is identical to that of the DMA controller shown in Figure 7. The host and the DSP both have access to the on-chip RAM at all times and host accesses are always synchronized to the DSP clock. If the host and the DSP contend for access to the same location, the host has priority, and the DSP waits for one HPI8 cycle. Note that since host accesses are always synchronized to the 5402 clock, an active input clock (CLKIN) is required for HPI8 accesses during IDLE states, and host accesses are not allowed while the 5402 reset pin is asserted.

The HPI8 interface consists of an 8-bit bidirectional data bus and various control signals. Sixteen-bit transfers are accomplished in two parts with the HBIL input designating high or low byte. The host communicates with the HPI8 through three dedicated registers — HPI address register (HPIA), HPI data register (HPID), and an HPI control register (HPIC). The HPIA and HPID registers are only accessible by the host, and the HPIC register is accessible by both the host and the 5402.
multichannel buffered serial ports

The 5402 device includes two high-speed, full-duplex multichannel buffered serial ports (McBSPs) that allow direct interface to other 'C54x/LC54x devices, codecs, and other devices in a system. The McBSPs are based on the standard serial port interface found on other 54x devices. Like its predecessors, the McBSP provides:

- Full-duplex communication
- Double-buffered data registers, which allow a continuous data stream
- Independent framing and clocking for receive and transmit

In addition, the McBSP has the following capabilities:

- Direct interface to:
  - T1/E1 framers
  - MVIP switching compatible and ST-BUS compliant devices
  - IOM-2 compliant devices
  - Serial peripheral interface devices
- Multichannel transmit and receive of up to 128 channels
- A wide selection of data sizes including 8, 12, 16, 20, 24, or 32 bits
- μ-law and A-law companding
- Programmable polarity for both frame synchronization and data clocks
- Programmable internal clock and frame generation

The McBSPs consist of separate transmit and receive channels that operate independently. The external interface of each McBSP consists of the following pins:

- BCLKX  Transmit reference clock
- BDX  Transmit data
- BFSX  Transmit frame synchronization
- BCLKR  Receive reference clock
- BDR  Receive data
- BFSR  Receive frame synchronization

The six pins listed are functionally equivalent to previous serial port interface pins in the 'C5000 family of DSPs. On the transmitter, transmit frame synchronization and clocking are indicated by the BFSX and BCLKX pins, respectively. The CPU or DMA can initiate transmission of data by writing to the data transmit register (DXR). Data written to DXR is shifted out on the BDX pin through a transmit shift register (XSR). This structure allows DXR to be loaded with the next word to be sent while the transmission of the current word is in progress.
multichannel buffered serial ports (continued)

On the receiver, receive frame synchronization and clocking are indicated by the BFSR and BCLKR pins, respectively. The CPU or DMA can read received data from the data receive register (DRR). Data received on the BDR pin is shifted into a receive shift register (RSR) and then buffered in the receive buffer register (RBR). If the DRR is empty, the RBR contents are copied into the DRR. If not, the RBR holds the data until the DRR is available. This structure allows storage of the two previous words while the reception of the current word is in progress.

The CPU and DMA can move data to and from the McBSPs and can synchronize transfers based on McBSP interrupts, event signals, and status flags. The DMA is capable of handling data movement between the McBSPs and memory with no intervention from the CPU.

In addition to the standard serial port functions, the McBSP provides programmable clock and frame synchronization signals. The programmable functions include:

- Frame synchronization pulse width
- Frame period
- Frame synchronization delay
- Clock reference (internal vs. external)
- Clock division
- Clock and frame synchronization polarity

The on-chip companding hardware allows compression and expansion of data in either µ-law or A-law format. When companding is used, transmit data is encoded according to specified companding law and received data is decoded to 2s complement format.

The McBSP allows the multiple channels to be independently selected for the transmitter and receiver. When multiple channels are selected, each frame represents a time-division multiplexed (TDM) data stream. In using TDM data streams, the CPU may only need to process a few of them. Thus, to save memory and bus bandwidth, multichannel selection allows independent enabling of particular channels for transmission and reception. Up to 32 channels in a stream of up to 128 channels can be enabled.

The clock-stop mode (CLKSTP) in the McBSP provides compatibility with the serial peripheral interface (SPI) protocol. The word sizes supported by the McBSP are programmable for 8-, 12-, 16-, 20-, 24-, or 32-bit operation. When the McBSP is configured to operate in SPI mode, both the transmitter and the receiver operate together as a master or as a slave.

The McBSP is fully static and operates at arbitrarily low clock frequencies. The maximum frequency is CPU clock frequency divided by 2.

hardware timer

The 5402 device features two 16-bit timing circuits with 4-bit prescalers. The main counter of each timer is decremented by one every CLKOUT cycle. Each time the counter decrements to 0, a timer interrupt is generated. The timers can be stopped, restarted, reset, or disabled by specific control bits.

clock generator

The clock generator provides clocks to the 5402 device, and consists of an internal oscillator and a phase-locked loop (PLL) circuit. The clock generator requires a reference clock input, which can be provided by using a crystal resonator with the internal oscillator, or from an external clock source.

NOTE: All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
clock generator (continued)

The reference clock input is then divided by two (DIV mode) to generate clocks for the 5402 device, or the PLL circuit can be used (PLL mode) to generate the device clock by multiplying the reference clock frequency by a scale factor, allowing use of a clock source with a lower frequency than that of the CPU. The PLL is an adaptive circuit that, once synchronized, locks onto and tracks an input clock signal.

When the PLL is initially started, it enters a transitional mode during which the PLL acquires lock with the input signal. Once the PLL is locked, it continues to track and maintain synchronization with the input signal. Then, other internal clock circuitry allows the synthesis of new clock frequencies for use as master clock for the 5402 device.

This clock generator allows system designers to select the clock source. The sources that drive the clock generator are:

- A crystal resonator circuit. The crystal resonator circuit is connected across the X1 and X2/CLKIN pins of the 5402 to enable the internal oscillator.
- An external clock. The external clock source is directly connected to the X2/CLKIN pin, and X1 is left unconnected.

**NOTE:** All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.

The software-programmable PLL features a high level of flexibility, and includes a clock scaler that provides various clock multiplier ratios, capability to directly enable and disable the PLL, and a PLL lock timer that can be used to delay switching to PLL clocking mode of the device until lock is achieved. Devices that have a built-in software-programmable PLL can be configured in one of two clock modes:

- PLL mode. The input clock (X2/CLKIN) is multiplied by 1 of 31 possible ratios. These ratios are achieved using the PLL circuitry.
- DIV (divider) mode. The input clock is divided by 2 or 4. Note that when DIV mode is used, the PLL can be completely disabled in order to minimize power dissipation.

The software-programmable PLL is controlled using the 16-bit memory-mapped (address 0058h) clock mode register (CLKMD). The CLKMD register is used to define the configuration of the PLL clock module. Upon reset, the CLKMD register is initialized with a predetermined value dependent only upon the state of the CLKMD1 – CLKMD3 pins as shown in Table 5.

### Table 5. Clock Mode Settings at Reset

<table>
<thead>
<tr>
<th>CLKMD1</th>
<th>CLKMD2</th>
<th>CLKMD3</th>
<th>CLKMD RESET VALUE</th>
<th>CLOCK MODE</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>E007h</td>
<td>PLL x 15</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>1</td>
<td>9007h</td>
<td>PLL x 10</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>0</td>
<td>4007h</td>
<td>PLL x 5</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>0</td>
<td>1007h</td>
<td>PLL x 2</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>0</td>
<td>F007h</td>
<td>PLL x 1</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>1</td>
<td>00000h</td>
<td>1/2 (PLL disabled)</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>1</td>
<td>F000h</td>
<td>1/4 (PLL disabled)</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>1</td>
<td>—</td>
<td>Reserved (bypass mode)</td>
</tr>
</tbody>
</table>
DMA controller

The 5402 direct memory access (DMA) controller transfers data between points in the memory map without intervention by the CPU. The DMA controller allows movements of data to and from internal program/data memory or internal peripherals (such as the McBSPs) to occur in the background of CPU operation. The DMA has six independent programmable channels allowing six different contexts for DMA operation.

features

The DMA has the following features:

- The DMA operates independently of the CPU.
- The DMA has six channels. The DMA can keep track of the contexts of six independent block transfers.
- The DMA has higher priority than the CPU for internal accesses.
- Each channel has independently programmable priorities.
- Each channel’s source and destination address registers can have configurable indexes through memory on each read and write transfer, respectively. The address may remain constant, be post-incremented, post-decremented, or be adjusted by a programmable value.
- Each read or write transfer may be initialized by selected events.
- Upon completion of a half-block or an entire-block transfer, each DMA channel may send an interrupt to the CPU.
- The DMA can perform double-word transfers (a 32-bit transfer of two 16-bit words).

DMA memory map

The DMA memory map is shown in Figure 7 to allow DMA transfers to be unaffected by the status of the MPMC, DROM, and OVLY bits.

![Figure 7. 5402 DMA Memory Map](image-url)
**DMA priority level**

Each DMA channel can be independently assigned high priority or low priority relative to each other. Multiple DMA channels that are assigned to the same priority level are handled in a round-robin manner.

**DMA source/destination address modification**

The DMA provides flexible address-indexing modes for easy implementation of data management schemes such as autobuffering and circular buffers. Source and destination addresses can be indexed separately and can be post-incremented, post-decremented, or post-incremented with a specified index offset.

**DMA in autoinitialization mode**

The DMA can automatically reinitialize itself after completion of a block transfer. Some of the DMA registers can be preloaded for the next block transfer through the DMA global reload registers (DMGSA, DMGDA, and DMGCR). Autoinitialization allows:

- Continuous operation: Normally, the CPU would have to reinitialize the DMA immediately after the completion of the current block transfer; but with the global reload registers, it can reinitialize these values for the next block transfer any time after the current block transfer begins.
- Repetitive operation: The CPU does not preload the global reload register with new values for each block transfer but only loads them on the first block transfer.

**DMA transfer counting**

The DMA channel element count register (DMCTRx) and the frame count register (DMSFCx) contain bit fields that represent the number of frames and the number of elements per frame to be transferred.

- Frame count. This 8-bit value defines the total number of frames in the block transfer. The maximum number of frames per block transfer is 128 (FRAME COUNT = 0ffh). The counter is decremented upon the last read transfer in a frame transfer. Once the last frame is transferred, the selected 8-bit counter is reloaded with the DMA global frame reload register (DMGFR) if the AUTOINIT bit is set to 1. A frame count of 0 (default value) means the block transfer contains a single frame.
- Element count. This 16-bit value defines the number of elements per frame. This counter is decremented after the read transfer of each element. The maximum number of elements per frame is 65536 (DMCTRn = 0FFFFh). In autoinitialization mode, once the last frame is transferred, the counter is reloaded with the DMA global count reload register (DMGCR).

**DMA transfers in double-word mode**

Double-word mode allows the DMA to transfer 32-bit words in any index mode. In double-word mode, two consecutive 16-bit transfers are initiated and the source and destination addresses are automatically updated following each transfer. In this mode, each 32-bit word is considered to be one element.

**DMA channel index registers**

The particular DMA channel index register is selected by way of the SIND and DIND field in the DMA mode control register (DMMCRx). Unlike basic address adjustment, in conjunction with the frame index DMFRI0 and DMFRI1, the DMA allows different adjustment amounts depending on whether or not the element transfer is the last in the current frame. The normal adjustment value (element index) is contained in the element index registers DMIDX0 and DMIDX1. The adjustment value (frame index) for the end of the frame, is determined by the selected DMA frame index register, either DMFRI0 or DMFRI1.
DMA channel index registers (continued)

The element index and the frame index affect address adjustment as follows:

- **Element index**: For all except the last transfer in the frame, the element index determines the amount to be added to the DMA channel for the source/destination address register (DMSRCx/DMDSTx) as selected by the SIND/DIND bits.

- **Frame index**: If the transfer is the last in a frame, the frame index is used for address adjustment as selected by the SIND/DIND bits. This occurs in both single-frame and multi-frame transfer.

DMA interrupts

The ability of the DMA to interrupt the CPU based on the status of the data transfer is configurable and is determined by the IMOD and DINM bits in the DMA channel mode control register (DMMCRn). The available modes are shown in Table 6.

### Table 6. DMA Interrupts

<table>
<thead>
<tr>
<th>MODE</th>
<th>DINM</th>
<th>IMOD</th>
<th>INTERRUPT</th>
</tr>
</thead>
<tbody>
<tr>
<td>ABU (non-decrement)</td>
<td>1</td>
<td>0</td>
<td>At full buffer only</td>
</tr>
<tr>
<td>ABU (non-decrement)</td>
<td>1</td>
<td>1</td>
<td>At half buffer and full buffer</td>
</tr>
<tr>
<td>Multi-Frame</td>
<td>1</td>
<td>0</td>
<td>At block transfer complete (DMCTRn = DMSEFCn[7:0] = 0)</td>
</tr>
<tr>
<td>Multi-Frame</td>
<td>1</td>
<td>1</td>
<td>At end of frame and end of block (DMCTRn = 0)</td>
</tr>
<tr>
<td>Either</td>
<td>0</td>
<td>X</td>
<td>No interrupt generated</td>
</tr>
<tr>
<td>Either</td>
<td>0</td>
<td>X</td>
<td>No interrupt generated</td>
</tr>
</tbody>
</table>

DMA controller synchronization events

The transfers associated with each DMA channel can be synchronized to one of several events. The DSYN bit field of the DMA channel x sync select and frame count (DMSFCx) register selects the synchronization event for a channel. The list of possible events and the DSYN values are shown in Table 7.

### Table 7. DMA Synchronization Events

<table>
<thead>
<tr>
<th>DSYN VALUE</th>
<th>DMA SYNCHRONIZATION EVENT</th>
</tr>
</thead>
<tbody>
<tr>
<td>0000b</td>
<td>No synchronization used</td>
</tr>
<tr>
<td>0001b</td>
<td>McBSP0 receive event</td>
</tr>
<tr>
<td>0010b</td>
<td>McBSP0 transmit event</td>
</tr>
<tr>
<td>0011−0100b</td>
<td>Reserved</td>
</tr>
<tr>
<td>0101b</td>
<td>McBSP1 receive event</td>
</tr>
<tr>
<td>0110b</td>
<td>McBSP1 transmit event</td>
</tr>
<tr>
<td>0111b−0110b</td>
<td>Reserved</td>
</tr>
<tr>
<td>1101b</td>
<td>Timer0 interrupt</td>
</tr>
<tr>
<td>1110b</td>
<td>External interrupt 3</td>
</tr>
<tr>
<td>1111b</td>
<td>Timer1 interrupt</td>
</tr>
</tbody>
</table>
DMA channel interrupt selection

The DMA controller can generate a CPU interrupt for each of the six channels. However, the interrupt sources for channels 0, 1, 2, and 3 are multiplexed with other interrupt sources. DMA channels 2 and 3 share an interrupt line with the receive and transmit portions of McBSP1 (IMR/IFR bits 10 and 11), and DMA channel 1 shares an interrupt line with timer 1 (IMR/IFR bit 7). The interrupt source for DMA channel 0 is shared with a reserved interrupt source. When the 5402 is reset, the interrupts from these four DMA channels are deselected. The INTSEL bit field in the DMA channel priority and enable control (DMPREC) register can be used to select these interrupts, as shown in Table 8.

Table 8. DMA Channel Interrupt Selection

<table>
<thead>
<tr>
<th></th>
<th></th>
<th></th>
<th></th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>00b (reset)</td>
<td>Reserved</td>
<td>TINT1</td>
<td>BRINT1</td>
<td>BXINT1</td>
</tr>
<tr>
<td>01b</td>
<td>Reserved</td>
<td>TINT1</td>
<td>DMAC2</td>
<td>DMAC3</td>
</tr>
<tr>
<td>10b</td>
<td>DMAC0</td>
<td>DMAC1</td>
<td>DMAC2</td>
<td>DMAC3</td>
</tr>
<tr>
<td>11b</td>
<td></td>
<td></td>
<td></td>
<td>Reserved</td>
</tr>
</tbody>
</table>
memory-mapped registers

The 5402 has 27 memory-mapped CPU registers, which are mapped in data memory space addresses 0h to 1Fh. Table 9 gives a list of CPU memory-mapped registers (MMRs) available on 5402. The device also has a set of memory-mapped registers associated with peripherals. Table 10, Table 11, and Table 12 show additional peripheral MMRs associated with the 5402.

Table 9. CPU Memory-Mapped Registers

<table>
<thead>
<tr>
<th>NAME</th>
<th>ADDRESS</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>IMR</td>
<td>0</td>
<td>Interrupt mask register</td>
</tr>
<tr>
<td>IFR</td>
<td>1</td>
<td>Interrupt flag register</td>
</tr>
<tr>
<td>–</td>
<td>2–5</td>
<td>Reserved for testing</td>
</tr>
<tr>
<td>ST0</td>
<td>6</td>
<td>Status register 0</td>
</tr>
<tr>
<td>ST1</td>
<td>7</td>
<td>Status register 1</td>
</tr>
<tr>
<td>AL</td>
<td>8</td>
<td>Accumulator A low word (15–0)</td>
</tr>
<tr>
<td>AH</td>
<td>9</td>
<td>Accumulator A high word (31–16)</td>
</tr>
<tr>
<td>AG</td>
<td>10</td>
<td>Accumulator A guard bits (39–32)</td>
</tr>
<tr>
<td>BL</td>
<td>11</td>
<td>Accumulator B low word (15–0)</td>
</tr>
<tr>
<td>BH</td>
<td>12</td>
<td>Accumulator B high word (31–16)</td>
</tr>
<tr>
<td>BG</td>
<td>13</td>
<td>Accumulator B guard bits (39–32)</td>
</tr>
<tr>
<td>TREG</td>
<td>14</td>
<td>Temporary register</td>
</tr>
<tr>
<td>TRN</td>
<td>15</td>
<td>Transition register</td>
</tr>
<tr>
<td>AR0</td>
<td>16</td>
<td>Auxiliary register 0</td>
</tr>
<tr>
<td>AR1</td>
<td>17</td>
<td>Auxiliary register 1</td>
</tr>
<tr>
<td>AR2</td>
<td>18</td>
<td>Auxiliary register 2</td>
</tr>
<tr>
<td>AR3</td>
<td>19</td>
<td>Auxiliary register 3</td>
</tr>
<tr>
<td>AR4</td>
<td>20</td>
<td>Auxiliary register 4</td>
</tr>
<tr>
<td>AR5</td>
<td>21</td>
<td>Auxiliary register 5</td>
</tr>
<tr>
<td>AR6</td>
<td>22</td>
<td>Auxiliary register 6</td>
</tr>
<tr>
<td>AR7</td>
<td>23</td>
<td>Auxiliary register 7</td>
</tr>
<tr>
<td>SP</td>
<td>24</td>
<td>Stack pointer register</td>
</tr>
<tr>
<td>BK</td>
<td>25</td>
<td>Circular buffer size register</td>
</tr>
<tr>
<td>BRC</td>
<td>26</td>
<td>Block repeat counter</td>
</tr>
<tr>
<td>RSA</td>
<td>27</td>
<td>Block repeat start address</td>
</tr>
<tr>
<td>REA</td>
<td>28</td>
<td>Block repeat end address</td>
</tr>
<tr>
<td>PMST</td>
<td>29</td>
<td>Processor mode status (PMST) register</td>
</tr>
<tr>
<td>XPC</td>
<td>30</td>
<td>Extended program page register</td>
</tr>
<tr>
<td>–</td>
<td>31</td>
<td>Reserved</td>
</tr>
</tbody>
</table>
memory-mapped registers (continued)

Table 10. Peripheral Memory-Mapped Registers

<table>
<thead>
<tr>
<th>NAME</th>
<th>ADDRESS</th>
<th>DESCRIPTION</th>
<th>TYPE</th>
</tr>
</thead>
<tbody>
<tr>
<td>DRR20</td>
<td>20h</td>
<td>McBSP0 data receive register 2</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>DRR10</td>
<td>21h</td>
<td>McBSP0 data receive register 1</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>DXR20</td>
<td>22h</td>
<td>McBSP0 data transmit register 2</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>DXR10</td>
<td>23h</td>
<td>McBSP0 data transmit register 1</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>TIM</td>
<td>24h</td>
<td>Timer0 register</td>
<td>Timer0</td>
</tr>
<tr>
<td>PRD</td>
<td>25h</td>
<td>Timer0 period counter</td>
<td>Timer0</td>
</tr>
<tr>
<td>TCR</td>
<td>26h</td>
<td>Timer0 control register</td>
<td>Timer0</td>
</tr>
<tr>
<td>–</td>
<td>27h</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>SWWSR</td>
<td>28h</td>
<td>Software wait-state register</td>
<td>External Bus</td>
</tr>
<tr>
<td>BSCR</td>
<td>29h</td>
<td>Bank-switching control register</td>
<td>External Bus</td>
</tr>
<tr>
<td>–</td>
<td>2Ah</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>SWCR</td>
<td>2Bh</td>
<td>Software wait-state control register</td>
<td>External Bus</td>
</tr>
<tr>
<td>HPIC</td>
<td>2Ch</td>
<td>HPI control register</td>
<td>HPI</td>
</tr>
<tr>
<td>–</td>
<td>2Dh–2Fh</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>TIM1</td>
<td>30h</td>
<td>Timer1 register</td>
<td>Timer1</td>
</tr>
<tr>
<td>PRD1</td>
<td>31h</td>
<td>Timer1 period counter</td>
<td>Timer1</td>
</tr>
<tr>
<td>TCR1</td>
<td>32h</td>
<td>Timer1 control register</td>
<td>Timer1</td>
</tr>
<tr>
<td>–</td>
<td>33h–37h</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>SPSA0</td>
<td>38h</td>
<td>McBSP0 subbank address register †</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>SPSD0</td>
<td>39h</td>
<td>McBSP0 subbank data register †</td>
<td>McBSP #0</td>
</tr>
<tr>
<td>–</td>
<td>3Ah–3Bh</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>GPIOCR</td>
<td>3Ch</td>
<td>General-purpose I/O pins control register</td>
<td>GPIO</td>
</tr>
<tr>
<td>GPIOSR</td>
<td>3Dh</td>
<td>General-purpose I/O pins status register</td>
<td>GPIO</td>
</tr>
<tr>
<td>–</td>
<td>3Eh–3Fh</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>DRR21</td>
<td>40h</td>
<td>McBSP1 data receive register 2</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>DRR11</td>
<td>41h</td>
<td>McBSP1 data receive register 1</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>DXR21</td>
<td>42h</td>
<td>McBSP1 data transmit register 2</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>DXR11</td>
<td>43h</td>
<td>McBSP1 data transmit register 1</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>–</td>
<td>44h–47h</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>SPSA1</td>
<td>48h</td>
<td>McBSP1 subbank address register †</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>SPSD1</td>
<td>49h</td>
<td>McBSP1 subbank data register †</td>
<td>McBSP #1</td>
</tr>
<tr>
<td>–</td>
<td>4Ah–53h</td>
<td>Reserved</td>
<td></td>
</tr>
<tr>
<td>DMPREC</td>
<td>54h</td>
<td>DMA channel priority and enable control register</td>
<td>DMA</td>
</tr>
<tr>
<td>DMSA</td>
<td>55h</td>
<td>DMA subbank address register ‡</td>
<td>DMA</td>
</tr>
<tr>
<td>DMSDI</td>
<td>56h</td>
<td>DMA subbank data register with autoincrement ‡</td>
<td>DMA</td>
</tr>
<tr>
<td>DMSDN</td>
<td>57h</td>
<td>DMA subbank data register ‡</td>
<td>DMA</td>
</tr>
<tr>
<td>CLKMD</td>
<td>58h</td>
<td>Clock mode register</td>
<td>PLL</td>
</tr>
<tr>
<td>–</td>
<td>59h–5Fh</td>
<td>Reserved</td>
<td></td>
</tr>
</tbody>
</table>

† See Table 11 for a detailed description of the McBSP control registers and their sub-addresses.
‡ See Table 12 for a detailed description of the DMA subbank addressed registers.
McBSP control registers and subaddresses

The control registers for the multichannel buffered serial port (McBSP) are accessed using the subbank addressing scheme. This allows a set or subbank of registers to be accessed through a single memory location. The serial port subbank address (SPSA) register is used as a pointer to select a particular register within the subbank. The serial port subbank data (SPSD) register is used to access (read or write) the selected register. Table 11 shows the McBSP control registers and their corresponding sub-addresses.

Table 11. McBSP Control Registers and Subaddresses

<table>
<thead>
<tr>
<th>McBSP0 NAME</th>
<th>ADDRESS</th>
<th>McBSP1 NAME</th>
<th>ADDRESS</th>
<th>SUB-ADDRESS</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>SPCR10</td>
<td>39h</td>
<td>SPCR11</td>
<td>49h</td>
<td>00h</td>
<td>Serial port control register 1</td>
</tr>
<tr>
<td>SPCR20</td>
<td>39h</td>
<td>SPCR21</td>
<td>49h</td>
<td>01h</td>
<td>Serial port control register 2</td>
</tr>
<tr>
<td>RCR10</td>
<td>39h</td>
<td>RCR11</td>
<td>49h</td>
<td>02h</td>
<td>Receive control register 1</td>
</tr>
<tr>
<td>RCR20</td>
<td>39h</td>
<td>RCR21</td>
<td>49h</td>
<td>03h</td>
<td>Receive control register 2</td>
</tr>
<tr>
<td>XCR10</td>
<td>39h</td>
<td>XCR11</td>
<td>49h</td>
<td>04h</td>
<td>Transmit control register 1</td>
</tr>
<tr>
<td>XCR20</td>
<td>39h</td>
<td>XCR21</td>
<td>49h</td>
<td>05h</td>
<td>Transmit control register 2</td>
</tr>
<tr>
<td>SRGR10</td>
<td>39h</td>
<td>SRGR11</td>
<td>49h</td>
<td>06h</td>
<td>Sample rate generator register 1</td>
</tr>
<tr>
<td>SRGR20</td>
<td>39h</td>
<td>SRGR21</td>
<td>49h</td>
<td>07h</td>
<td>Sample rate generator register 2</td>
</tr>
<tr>
<td>MCR10</td>
<td>39h</td>
<td>MCR11</td>
<td>49h</td>
<td>08h</td>
<td>Multichannel register 1</td>
</tr>
<tr>
<td>MCR20</td>
<td>39h</td>
<td>MCR21</td>
<td>49h</td>
<td>09h</td>
<td>Multichannel register 2</td>
</tr>
<tr>
<td>RCRA0</td>
<td>39h</td>
<td>RCRA1</td>
<td>49h</td>
<td>0Ah</td>
<td>Receive channel enable register partition A</td>
</tr>
<tr>
<td>RCRA0</td>
<td>39h</td>
<td>RCRA1</td>
<td>49h</td>
<td>0Ah</td>
<td>Receive channel enable register partition B</td>
</tr>
<tr>
<td>XERA0</td>
<td>39h</td>
<td>XERA1</td>
<td>49h</td>
<td>0Ch</td>
<td>Transmit channel enable register partition A</td>
</tr>
<tr>
<td>XERA0</td>
<td>39h</td>
<td>XERA1</td>
<td>49h</td>
<td>0Dh</td>
<td>Transmit channel enable register partition B</td>
</tr>
<tr>
<td>PCR0</td>
<td>39h</td>
<td>PCR1</td>
<td>49h</td>
<td>0Eh</td>
<td>Pin control register</td>
</tr>
</tbody>
</table>

DMA subbank addressed registers

The direct memory access (DMA) controller has several control registers associated with it. The main control register (DMPREC) is a standard memory-mapped register. However, the other registers are accessed using the subbank addressing scheme. This allows a set or subbank of registers to be accessed through a single memory location. The DMA subbank address (DMSA) register is used as a pointer to select a particular register within the subbank, while the DMA subbank data (DMSDN) register or the DMA subbank data register with autoincrement (DMSDI) is used to access (read or write) the selected register.

When the DMSDI register is used to access the subbank, the subbank address is automatically post-incremented so that a subsequent access affects the next register within the subbank. This autoincrement feature is intended for efficient, successive accesses to several control registers. If the autoincrement feature is not required, the DMSDN register should be used to access the subbank. Table 12 shows the DMA controller subbank addressed registers and their corresponding subaddresses.
### DMA subbank addressed registers (continued)

**Table 12. DMA Subbank Addressed Registers**

<table>
<thead>
<tr>
<th>DMA NAME</th>
<th>DMA ADDRESS</th>
<th>SUB-ADDRESS</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>DMSRC0</td>
<td>56h/57h</td>
<td>00h</td>
<td>DMA channel 0 source address register</td>
</tr>
<tr>
<td>DMGST0</td>
<td>56h/57h</td>
<td>01h</td>
<td>DMA channel 0 destination address register</td>
</tr>
<tr>
<td>DMCTR0</td>
<td>56h/57h</td>
<td>02h</td>
<td>DMA channel 0 element count register</td>
</tr>
<tr>
<td>DMSFC0</td>
<td>56h/57h</td>
<td>03h</td>
<td>DMA channel 0 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR0</td>
<td>56h/57h</td>
<td>04h</td>
<td>DMA channel 0 transfer mode control register</td>
</tr>
<tr>
<td>DMSRC1</td>
<td>56h/57h</td>
<td>05h</td>
<td>DMA channel 1 source address register</td>
</tr>
<tr>
<td>DMGST1</td>
<td>56h/57h</td>
<td>06h</td>
<td>DMA channel 1 destination address register</td>
</tr>
<tr>
<td>DMCTR1</td>
<td>56h/57h</td>
<td>07h</td>
<td>DMA channel 1 element count register</td>
</tr>
<tr>
<td>DMSFC1</td>
<td>56h/57h</td>
<td>08h</td>
<td>DMA channel 1 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR1</td>
<td>56h/57h</td>
<td>09h</td>
<td>DMA channel 1 transfer mode control register</td>
</tr>
<tr>
<td>DMSRC2</td>
<td>56h/57h</td>
<td>0Ah</td>
<td>DMA channel 2 source address register</td>
</tr>
<tr>
<td>DMGST2</td>
<td>56h/57h</td>
<td>0Bh</td>
<td>DMA channel 2 destination address register</td>
</tr>
<tr>
<td>DMCTR2</td>
<td>56h/57h</td>
<td>0Ch</td>
<td>DMA channel 2 element count register</td>
</tr>
<tr>
<td>DMSFC2</td>
<td>56h/57h</td>
<td>0Dh</td>
<td>DMA channel 2 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR2</td>
<td>56h/57h</td>
<td>0Eh</td>
<td>DMA channel 2 transfer mode control register</td>
</tr>
<tr>
<td>DMSRC3</td>
<td>56h/57h</td>
<td>0Fh</td>
<td>DMA channel 3 source address register</td>
</tr>
<tr>
<td>DMGST3</td>
<td>56h/57h</td>
<td>10h</td>
<td>DMA channel 3 destination address register</td>
</tr>
<tr>
<td>DMCTR3</td>
<td>56h/57h</td>
<td>11h</td>
<td>DMA channel 3 element count register</td>
</tr>
<tr>
<td>DMSFC3</td>
<td>56h/57h</td>
<td>12h</td>
<td>DMA channel 3 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR3</td>
<td>56h/57h</td>
<td>13h</td>
<td>DMA channel 3 transfer mode control register</td>
</tr>
<tr>
<td>DMSRC4</td>
<td>56h/57h</td>
<td>14h</td>
<td>DMA channel 4 source address register</td>
</tr>
<tr>
<td>DMGST4</td>
<td>56h/57h</td>
<td>15h</td>
<td>DMA channel 4 destination address register</td>
</tr>
<tr>
<td>DMCTR4</td>
<td>56h/57h</td>
<td>16h</td>
<td>DMA channel 4 element count register</td>
</tr>
<tr>
<td>DMSFC4</td>
<td>56h/57h</td>
<td>17h</td>
<td>DMA channel 4 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR4</td>
<td>56h/57h</td>
<td>18h</td>
<td>DMA channel 4 transfer mode control register</td>
</tr>
<tr>
<td>DMSRC5</td>
<td>56h/57h</td>
<td>19h</td>
<td>DMA channel 5 source address register</td>
</tr>
<tr>
<td>DMGST5</td>
<td>56h/57h</td>
<td>1Ah</td>
<td>DMA channel 5 destination address register</td>
</tr>
<tr>
<td>DMCTR5</td>
<td>56h/57h</td>
<td>1Bh</td>
<td>DMA channel 5 element count register</td>
</tr>
<tr>
<td>DMSFC5</td>
<td>56h/57h</td>
<td>1Ch</td>
<td>DMA channel 5 sync select and frame count register</td>
</tr>
<tr>
<td>DMMCR5</td>
<td>56h/57h</td>
<td>1Dh</td>
<td>DMA channel 5 transfer mode control register</td>
</tr>
<tr>
<td>DMSRCP</td>
<td>56h/57h</td>
<td>1Eh</td>
<td>DMA source program page address (common channel)</td>
</tr>
<tr>
<td>DMGSTP</td>
<td>56h/57h</td>
<td>1Fh</td>
<td>DMA destination program page address (common channel)</td>
</tr>
<tr>
<td>DMIDX0</td>
<td>56h/57h</td>
<td>20h</td>
<td>DMA element index address register 0</td>
</tr>
<tr>
<td>DMIDX1</td>
<td>56h/57h</td>
<td>21h</td>
<td>DMA element index address register 1</td>
</tr>
<tr>
<td>DMFR10</td>
<td>56h/57h</td>
<td>22h</td>
<td>DMA frame index register 0</td>
</tr>
<tr>
<td>DMFR11</td>
<td>56h/57h</td>
<td>23h</td>
<td>DMA frame index register 1</td>
</tr>
<tr>
<td>DMGSA</td>
<td>56h/57h</td>
<td>24h</td>
<td>DMA global source address reload register</td>
</tr>
<tr>
<td>DMGDA</td>
<td>56h/57h</td>
<td>25h</td>
<td>DMA global destination address reload register</td>
</tr>
<tr>
<td>DMGCR</td>
<td>56h/57h</td>
<td>26h</td>
<td>DMA global count reload register</td>
</tr>
<tr>
<td>DMGFR</td>
<td>56h/57h</td>
<td>27h</td>
<td>DMA global frame count reload register</td>
</tr>
</tbody>
</table>
interrupts

Vector-relative locations and priorities for all internal and external interrupts are shown in Table 13.

Table 13. Interrupt Locations and Priorities

<table>
<thead>
<tr>
<th>NAME</th>
<th>LOCATION</th>
<th>PRIORITY</th>
<th>FUNCTION</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>DECIMAL</td>
<td>HEX</td>
<td></td>
</tr>
<tr>
<td>RS, SINTR</td>
<td>0</td>
<td>00</td>
<td>1</td>
</tr>
<tr>
<td>NMI, SINT16</td>
<td>4</td>
<td>04</td>
<td>2</td>
</tr>
<tr>
<td>SINT17</td>
<td>8</td>
<td>08</td>
<td>—</td>
</tr>
<tr>
<td>SINT18</td>
<td>12</td>
<td>0C</td>
<td>—</td>
</tr>
<tr>
<td>SINT19</td>
<td>16</td>
<td>10</td>
<td>—</td>
</tr>
<tr>
<td>SINT20</td>
<td>20</td>
<td>14</td>
<td>—</td>
</tr>
<tr>
<td>SINT21</td>
<td>24</td>
<td>18</td>
<td>—</td>
</tr>
<tr>
<td>SINT22</td>
<td>28</td>
<td>1C</td>
<td>—</td>
</tr>
<tr>
<td>SINT23</td>
<td>32</td>
<td>20</td>
<td>—</td>
</tr>
<tr>
<td>SINT24</td>
<td>36</td>
<td>24</td>
<td>—</td>
</tr>
<tr>
<td>SINT25</td>
<td>40</td>
<td>28</td>
<td>—</td>
</tr>
<tr>
<td>SINT26</td>
<td>44</td>
<td>2C</td>
<td>—</td>
</tr>
<tr>
<td>SINT27</td>
<td>48</td>
<td>30</td>
<td>—</td>
</tr>
<tr>
<td>SINT28</td>
<td>52</td>
<td>34</td>
<td>—</td>
</tr>
<tr>
<td>SINT29</td>
<td>56</td>
<td>38</td>
<td>—</td>
</tr>
<tr>
<td>SINT30</td>
<td>60</td>
<td>3C</td>
<td>—</td>
</tr>
<tr>
<td>INT0, SINT0</td>
<td>64</td>
<td>40</td>
<td>3</td>
</tr>
<tr>
<td>INT1, SINT1</td>
<td>68</td>
<td>44</td>
<td>4</td>
</tr>
<tr>
<td>INT2, SINT2</td>
<td>72</td>
<td>48</td>
<td>5</td>
</tr>
<tr>
<td>TINT0, SINT3</td>
<td>76</td>
<td>4C</td>
<td>6</td>
</tr>
<tr>
<td>BRINT0, SINT4</td>
<td>80</td>
<td>50</td>
<td>7</td>
</tr>
<tr>
<td>BXINT0, SINT5</td>
<td>84</td>
<td>54</td>
<td>8</td>
</tr>
<tr>
<td>Reserved(DMAC0),</td>
<td>88</td>
<td>58</td>
<td>9</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>INT3, SINT8</td>
<td>96</td>
<td>60</td>
<td>11</td>
</tr>
<tr>
<td>HPINT, SINT9</td>
<td>100</td>
<td>64</td>
<td>12</td>
</tr>
<tr>
<td>BRINT1(DMAC2), SINT10</td>
<td>104</td>
<td>68</td>
<td>13</td>
</tr>
<tr>
<td>BXINT1(DMAC3), SINT11</td>
<td>108</td>
<td>6C</td>
<td>14</td>
</tr>
<tr>
<td>DMAC4,SINT12</td>
<td>112</td>
<td>70</td>
<td>15</td>
</tr>
<tr>
<td>DMAC5,SINT13</td>
<td>116</td>
<td>74</td>
<td>16</td>
</tr>
<tr>
<td>Reserved</td>
<td>120–127</td>
<td>78–7F</td>
<td>—</td>
</tr>
</tbody>
</table>
interrupts (continued)

The bits of the interrupt flag register (IFR) and interrupt mask register (IMR) are arranged as shown in Figure 8.

![Figure 8. IFR and IMR Registers](image)

<table>
<thead>
<tr>
<th>BIT</th>
<th>FUNCTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15−14</td>
<td>Reserved for future expansion</td>
</tr>
<tr>
<td>13</td>
<td>DMAC5</td>
</tr>
<tr>
<td>12</td>
<td>DMAC4</td>
</tr>
<tr>
<td>11</td>
<td>BXINT1/DMAC3</td>
</tr>
<tr>
<td>10</td>
<td>BRINT1/DMAC2</td>
</tr>
<tr>
<td>9</td>
<td>HPINT</td>
</tr>
<tr>
<td>8</td>
<td>INT3</td>
</tr>
<tr>
<td>7</td>
<td>TINT1/DMAC1</td>
</tr>
<tr>
<td>6</td>
<td>DMAC0</td>
</tr>
<tr>
<td>5</td>
<td>BXINT0</td>
</tr>
<tr>
<td>4</td>
<td>BRINT0</td>
</tr>
<tr>
<td>3</td>
<td>TINT0</td>
</tr>
<tr>
<td>2</td>
<td>INT2</td>
</tr>
<tr>
<td>1</td>
<td>INT1</td>
</tr>
<tr>
<td>0</td>
<td>INT0</td>
</tr>
</tbody>
</table>
support

notices concerning JTAG (IEEE 1149.1) boundary scan test capability

*initialization requirements for boundary scan test*

The 5402 uses the JTAG port for boundary scan tests, emulation capability and factory test purposes. To use boundary scan test, the EMU0 and EMU1/OFF pins must be held HIGH through a rising edge of the TRST signal prior to the first scan. This operation selects the appropriate TAP control for boundary scan. If at any time during a boundary scan test a rising edge of TRST occurs when EMU0 or EMU1/OFF are not high, a factory test mode may be selected preventing boundary scan test from being completed. For this reason, it is recommended that EMU0 and EMU1/OFF be pulled or driven high at all times during boundary scan test.

*boundary scan description language (BSDL) model*

BSDL models are available on the web in the 5402 product folder under the “simulation models” section.

documentation support

Extensive documentation supports all TMS320™ DSP family of devices from product announcement through applications development. The following types of documentation are available to support the design and use of the C5000 family of DSPs:

- TMS320C54x™ *DSP Functional Overview* (literature number SPRU307)
- Device-specific data sheets (such as this document)
- Complete User Guides
- Development-support tools
- Hardware and software application reports

The five-volume *TMS320C54x DSP Reference Set* consists of:

- *Volume 1: CPU and Peripherals* (literature number SPRU131)
- *Volume 2: Mnemonic Instruction Set* (literature number SPRU172)
- *Volume 3: Algebraic Instruction Set* (literature number SPRU179)
- *Volume 4: Applications Guide* (literature number SPRU173)
- *Volume 5: Enhanced Peripherals* (literature number SPRU302)

The reference set describes in detail the TMS320C54x products currently available, and the hardware and software applications, including algorithms, for fixed-point TMS320 devices.

A series of DSP textbooks is published by Prentice-Hall and John Wiley & Sons to support digital signal processing research and education. The TMS320 newsletter, *Details on Signal Processing*, is published quarterly and distributed to update TMS320 customers on product information.

Information regarding TI™ DSP products is also available on the Worldwide Web at [http://www.ti.com](http://www.ti.com) uniform resource locator (URL).
support (continued)

device and development-support tool nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all TMS320™ DSP devices and support tools. Each TMS320™ DSP commercial family member has one of three prefixes: TMX, TMP, or TMS (e.g., TMS320C6412GDK600). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMX/TMDX) through fully qualified production devices/tools (TMS/TMDS).

Device development evolutionary flow:

**TMX** Experimental device that is not necessarily representative of the final device's electrical specifications

**TMP** Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification

**TMS** Fully qualified production device

Support tool development evolutionary flow:

**TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing.

**TMDS** Fully qualified development-support product

TMX and TMP devices and TMDX development-support tools are shipped against the following disclaimer: “Developmental product is intended for internal evaluation purposes.”

TMS devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI’s standard warranty applies.

Predictions show that prototype devices (TMX or TMP) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.
absolute maximum ratings over specified temperature range (unless otherwise noted)†

- Supply voltage I/O range, DVDD‡: −0.3 V to 4.0 V
- Supply voltage core range, CVDD‡: −0.3 V to 2.4 V
- Input voltage range, Vᵢ: −0.3 V to 4.5 V
- Output voltage range, VO: −0.3 V to 4.5 V
- Operating case temperature range, TC: −40°C to 100°C
- Storage temperature range, Tstg: −55°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

‡ All voltage values are with respect to VSS.

recommended operating conditions

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>DVDD</td>
<td>3</td>
<td>3.3</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>CVDD</td>
<td>1.7</td>
<td>1.8</td>
<td>1.98</td>
<td>V</td>
</tr>
<tr>
<td>VSS</td>
<td>0</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>VIH</td>
<td>2.2</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>VIL</td>
<td>0.3</td>
<td>0.6</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>IOH</td>
<td>−300</td>
<td></td>
<td></td>
<td>μA</td>
</tr>
<tr>
<td>IOL</td>
<td>1.5</td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>TC</td>
<td>−40</td>
<td>100</td>
<td></td>
<td>°C</td>
</tr>
</tbody>
</table>

§ Texas Instrument DSPs do not require specific power sequencing between the core supply and the I/O supply. However, systems should be designed to ensure that neither supply is powered up for extended periods of time if the other supply is below the proper operating voltage. Excessive exposure to these conditions can adversely affect the long term reliability of the devices. System-level concerns such as bus contention may require supply sequencing to be implemented. In this case, the core supply should be powered up at the same time as or prior to the I/O buffers and then powered down after the I/O buffers.

¶ All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.
### Electrical Characteristics over Recommended Operating Case Temperature Range

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Test Conditions</th>
<th>Min</th>
<th>Typ†</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>V_{OH}</strong></td>
<td>High-level output voltage</td>
<td>( I_{OH} = \text{MAX} )</td>
<td>2.4</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td><strong>V_{OL}</strong></td>
<td>Low-level output voltage</td>
<td>( I_{OL} = \text{MAX} )</td>
<td>0.4</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>( I_{IZ} )</td>
<td>Input current for outputs in high impedance</td>
<td>D[15:0], HD[7:0]</td>
<td>Bus holders enabled, ( DV_{DD} = \text{MAX}, V_I = V_{SS} ) to ( DV_{DD} )</td>
<td>-175</td>
<td>175</td>
</tr>
<tr>
<td></td>
<td>All other inputs</td>
<td>( DV_{DD} = \text{MAX}, V_O = V_{SS} ) to ( DV_{DD} )</td>
<td>-5</td>
<td>5</td>
<td>( \mu A )</td>
</tr>
<tr>
<td>( I_I )</td>
<td>Input current</td>
<td>X2/CLKIN( \ddagger )</td>
<td>With internal pulldown ( (V_I = V_{SS} ) to ( DV_{DD} ) )</td>
<td>-40</td>
<td>40</td>
</tr>
<tr>
<td></td>
<td>TRST</td>
<td>With internal pulldown</td>
<td>-5</td>
<td>300</td>
<td>( \mu A )</td>
</tr>
<tr>
<td></td>
<td>HPIENA</td>
<td>With internal pulldown</td>
<td>-5</td>
<td>300</td>
<td>( \mu A )</td>
</tr>
<tr>
<td></td>
<td>TMS, TCK, TDI, HPI§</td>
<td>With internal pullups, HPIENA = 0</td>
<td>-300</td>
<td>5</td>
<td>( \mu A )</td>
</tr>
<tr>
<td></td>
<td>All other input-only pins</td>
<td></td>
<td>-5</td>
<td>5</td>
<td>( \mu A )</td>
</tr>
<tr>
<td>( I_{DDC} )</td>
<td>Supply current, core CPU</td>
<td>( CV_{DD} = 1.8 ) V, ( f_{\text{clock}} = 100 ) MHz( \ddagger ), ( T_C = 25^\circ C )#</td>
<td>45</td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>( I_{DDP} )</td>
<td>Supply current, pins</td>
<td>( DV_{DD} = 3.3 ) V, ( f_{\text{clock}} = 100 ) MHz( \ddagger ), ( T_C = 25^\circ C )|</td>
<td></td>
<td>30</td>
<td></td>
</tr>
<tr>
<td>( I_{DD} )</td>
<td>Supply current, standby</td>
<td>IDLE2</td>
<td>PLL \times 1 ) mode, ( 100 ) MHz input</td>
<td>2</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>IDLE3</td>
<td>Divide-by-two mode, CLKIN stopped</td>
<td>20</td>
<td></td>
</tr>
<tr>
<td>( C_I )</td>
<td>Input capacitance</td>
<td></td>
<td>5</td>
<td></td>
<td>pF</td>
</tr>
<tr>
<td>( C_O )</td>
<td>Output capacitance</td>
<td></td>
<td>5</td>
<td></td>
<td>pF</td>
</tr>
</tbody>
</table>

† All values are typical unless otherwise specified.

† All revisions of the TMS320C5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin.

It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.

§ HPI input signals except for HPIENA.

¶ Clock mode: PLL \times 1 with external source

# This value represents the current consumption of the CPU, on-chip memory, and on-chip peripherals. Conditions include: program execution from on-chip RAM, with 50% usage of MAC and 50% usage of NOP instructions. Actual operating current varies with program being executed.

|| This value was obtained using the following conditions: external memory writes at a rate of 20 million writes per second, CLKOFF=0, full-duplex operation of McBSP0 and McBSP1 at a rate of 10 million bits per second each, and 15-pF loads on all outputs. For more details on how this calculation is performed, refer to the Calculation of TMS320C54x Power Dissipation Application Report (literature number SPRA164).
NOTE: The data sheet provides timing at the device pin. For output timing analysis, the tester pin electronics and its transmission line effects must be taken into account. A transmission line with a delay of 2 ns or longer can be used to produce the desired transmission line effect. The transmission line is intended as a load only. It is not necessary to add or subtract the transmission line delay (2 ns or longer) from the data sheet timings.

Input requirements in this data sheet are tested with an input slew rate of < 4 Volts per nanosecond (4 V/ns) at the device pin.

**Figure 9. Tester Pin Electronics**

**internal oscillator with external crystal**

The internal oscillator is enabled by connecting a crystal across X1 and X2/CLKIN. The frequency of CLKOUT is a multiple of the oscillator frequency. The multiply ratio is determined by the bit settings in the CLKMD register. The crystal should be in fundamental-mode operation, and parallel resonant, with an effective series resistance of 30 Ω and power dissipation of 1 mW.

The connection of the required circuit, consisting of the crystal and two load capacitors, is shown in Figure 10. The load capacitors, $C_1$ and $C_2$, should be chosen such that the equation below is satisfied. $C_L$ in the equation is the load specified for the crystal.

$$C_L = \frac{C_1 C_2}{C_1 + C_2}$$

**recommended operating conditions of internal oscillator with external crystal (see Figure 10)**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$f_{clock}$</td>
<td>10</td>
<td>20</td>
<td>MHz</td>
</tr>
</tbody>
</table>

**Figure 10. Internal Oscillator With External Crystal**
divide-by-two clock option (PLL disabled)

The frequency of the reference clock provided at the X2/CLKIN pin can be divided by a factor of two to generate the internal machine cycle. The selection of the clock mode is described in the clock generator section.

When an external clock source is used, the frequency injected must conform to specifications listed in the timing requirements table.

NOTE: All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.

**timing requirements (see Figure 11)**

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t(CI) Cycle time, X2/CLKIN</td>
<td>20 †</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CI) Fall time, X2/CLKIN</td>
<td>8</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CI) Rise time, X2/CLKIN</td>
<td>8</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

† This device utilizes a fully static design and therefore can operate with t(CI) approaching ∞. The device is characterized at frequencies approaching 0 Hz.

**switching characteristics over recommended operating conditions [H = 0.5t(CO)]† (see Figure 10, Figure 11, and the recommended operating conditions table)**

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t(CO) Cycle time, CLKOUT</td>
<td></td>
<td>10 ‡</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CH) Delay time, X2/CLKIN high to CLKOUT high/low</td>
<td>4</td>
<td>10</td>
<td>17</td>
<td>ns</td>
</tr>
<tr>
<td>t(CO) Fall time, CLKOUT</td>
<td>2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CO) Rise time, CLKOUT</td>
<td>2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CO) Pulse duration, CLKOUT low</td>
<td>H−2</td>
<td>H</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>t(CO) Pulse duration, CLKOUT high</td>
<td>H−2</td>
<td>H</td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

† This device utilizes a fully static design and therefore can operate with t(CI) approaching ∞. The device is characterized at frequencies approaching 0 Hz.

‡ It is recommended that the PLL clocking option be used for maximum frequency operation.

![Figure 11. External Divide-by-Two Clock Timing](image-url)
multiply-by-N clock option

The frequency of the reference clock provided at the X2/CLKIN pin can be multiplied by a factor of N to generate the internal machine cycle. The selection of the clock mode and the value of N is described in the clock generator section.

When an external clock source is used, the external frequency injected must conform to specifications listed in the timing requirements table.

NOTE: All revisions of the 5402 can be operated with an external clock source, provided that the proper voltage levels be driven on the X2/CLKIN pin. It should be noted that the X2/CLKIN pin is referenced to the device 1.8V power supply (CVdd), rather than the 3V I/O supply (DVdd). Refer to the recommended operating conditions section of this document for the allowable voltage levels of the X2/CLKIN pin.

timing requirements (see Figure 12)†

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>tc(CI)</td>
<td></td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Cycle time, X2/CLKIN</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Integer PLL multiplier N (N = 1−15)</td>
<td>20‡</td>
<td>200</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>PLL multiplier N = x.5</td>
<td>20‡</td>
<td>100</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>PLL multiplier N = x.25, x.75</td>
<td>20‡</td>
<td>50</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>tf(CI)</td>
<td>8</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Fall time, X2/CLKIN</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tr(CI)</td>
<td>8</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Rise time, X2/CLKIN</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

† N = Multiplication factor
‡ The multiplication factor and minimum X2/CLKIN cycle time should be chosen such that the resulting CLKOUT cycle time is within the specified range (tc(CO))

switching characteristics over recommended operating conditions [H = 0.5tc(CO)] (see Figure 10 and Figure 12)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>tc(CO)</td>
<td>10</td>
<td></td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>Cycle time, CLKOUT</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>td(CI-CO)</td>
<td>4</td>
<td>10</td>
<td>17</td>
<td>ns</td>
</tr>
<tr>
<td>Delay time, X2/CLKIN high/low to CLKOUT high/low</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tf(CO)</td>
<td>2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Fall time, CLKOUT</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tr(CO)</td>
<td>2</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Rise time, CLKOUT</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tw(COL)</td>
<td>H−2</td>
<td>H</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Pulse duration, CLKOUT low</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tw(COH)</td>
<td>H−2</td>
<td>H</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Pulse duration, CLKOUT high</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>tp</td>
<td>30</td>
<td></td>
<td>μs</td>
<td></td>
</tr>
<tr>
<td>Transitory phase, PLL lock up time</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

† N = Multiplication factor

Figure 12. External Multiply-by-One Clock Timing
memory and parallel I/O interface timing

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t\text{a}(A)M</td>
<td>2H−7</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>t\text{a}(MSTRBL)</td>
<td>2H−8</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>t\text{su}(D)R</td>
<td>6</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>t\text{h}(D)R</td>
<td>−2</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>t\text{h}(A-D)R</td>
<td>0</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>t\text{h}(D)MSTRBH</td>
<td>0</td>
<td>ns</td>
<td></td>
</tr>
</tbody>
</table>

† Address, PS, and DS timings are all included in timings referenced as address.

switching characteristics over recommended operating conditions for a memory read \((MSTRB = 0)†\) (see Figure 13)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t\text{d}(CLKL-A)</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>t\text{d}(CLKH-A)</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>t\text{d}(CLKL-MSL)</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>t\text{d}(CLKL-MSH)</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>t\text{h}(CLKL-A)R</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>t\text{h}(CLKH-A)R</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
</tbody>
</table>

† Address, PS, and DS timings are all included in timings referenced as address.
‡ In the case of a memory read preceded by a memory read
§ In the case of a memory read preceded by a memory write
memory and parallel I/O interface timing (continued)

NOTE A: A[19:16] are always driven low during accesses to external data space.

Figure 13. Memory Read (MSTRB = 0)
memory and parallel I/O interface timing (continued)

switching characteristics over recommended operating conditions for a memory write (MSTRB = 0) [H = 0.5 t_C(CO)]† (see Figure 14)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>td(CLKH-A)</td>
<td>Delay time, CLKOUT high to address valid‡</td>
<td>−2</td>
<td>3</td>
</tr>
<tr>
<td>td(CLKL-A)</td>
<td>Delay time, CLKOUT low to address valid§</td>
<td>−2</td>
<td>3</td>
</tr>
<tr>
<td>td(CLKL-MSL)</td>
<td>Delay time, CLKOUT low to MSTRB low</td>
<td>−1</td>
<td>3</td>
</tr>
<tr>
<td>td(CLKL-D)W</td>
<td>Delay time, CLKOUT low to data valid</td>
<td>0</td>
<td>6</td>
</tr>
<tr>
<td>td(CLKL-MSH)</td>
<td>Delay time, CLKOUT low to MSTRB high</td>
<td>−1</td>
<td>3</td>
</tr>
<tr>
<td>td(CLKH-RWL)</td>
<td>Delay time, CLKOUT high to R/W low</td>
<td>−1</td>
<td>3</td>
</tr>
<tr>
<td>td(CLKH-RWH)</td>
<td>Delay time, CLKOUT high to R/W high</td>
<td>−1</td>
<td>3</td>
</tr>
<tr>
<td>td(RWL-MSTRBL)</td>
<td>Delay time, R/W low to MSTRB low</td>
<td>H − 2</td>
<td>H + 1</td>
</tr>
<tr>
<td>th(A)W</td>
<td>Hold time, address valid after CLKOUT high‡</td>
<td>1</td>
<td>3</td>
</tr>
<tr>
<td>th(D)MSH</td>
<td>Hold time, write data valid after MSTRB high</td>
<td>H − 3</td>
<td>H + 6§</td>
</tr>
<tr>
<td>tw(SL)MS</td>
<td>Pulse duration, MSTRB low</td>
<td>2H − 2</td>
<td>ns</td>
</tr>
<tr>
<td>tsu(A)W</td>
<td>Setup time, address valid before MSTRB low</td>
<td>2H − 6</td>
<td>2H + 5§</td>
</tr>
<tr>
<td>tsu(D)MSH</td>
<td>Setup time, write data valid before MSTRB high</td>
<td>2H − 6</td>
<td>2H + 5§</td>
</tr>
<tr>
<td>ten(D−RWL)</td>
<td>Enable time, data bus driven after R/W low</td>
<td>H − 5</td>
<td>ns</td>
</tr>
<tr>
<td>tdis(RWH−D)</td>
<td>Disable time, R/W high to data bus high impedance</td>
<td>0</td>
<td>ns</td>
</tr>
</tbody>
</table>

† Address, PS, and DS timings are all included in timings referenced as address.
‡ In the case of a memory write preceded by a memory write
§ In the case of a memory write preceded by an I/O cycle
memory and parallel I/O interface timing (continued)

NOTE A: A[19:16] are always driven low during accesses to external data space.

Figure 14. Memory Write (MSTRB = 0)
memory and parallel I/O interface timing (continued)

timing requirements for a parallel I/O port read ($\text{IOSTRB} = 0$) \([H = 0.5 \ t_C(O)]\)\(^\dagger\) (see Figure 15)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$t_{\text{a(A)IO}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Access time, read data access from address valid</td>
<td>$3H−7$</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{\text{a(ISTRBL)IO}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Access time, read data access from $\text{IOSTRB}$ low</td>
<td>$2H−7$</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{\text{su(D)IOR}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Setup time, read data before CLKOUT high</td>
<td>$6$</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{\text{h(D)IOR}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Hold time, read data after CLKOUT high</td>
<td>$0$</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{\text{h(ISTRBH-D)R}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Hold time, read data after $\text{IOSTRB}$ high</td>
<td>$0$</td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

\(^\dagger\) Address and IS timings are included in timings referenced as address.

switching characteristics over recommended operating conditions for a parallel I/O port read ($\text{IOSTRB} = 0$)\(^\dagger\) (see Figure 15)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$t_{\text{d(CLKL-A)}}$</td>
<td>$−2$</td>
<td>$3$</td>
<td>ns</td>
</tr>
<tr>
<td>Delay time, CLKOUT low to address valid</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$t_{\text{d(CLKH-ISTRBL)}}$</td>
<td>$−2$</td>
<td>$3$</td>
<td>ns</td>
</tr>
<tr>
<td>Delay time, CLKOUT high to $\text{IOSTRB}$ low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$t_{\text{d(CLKH-ISTRBH)}}$</td>
<td>$−2$</td>
<td>$3$</td>
<td>ns</td>
</tr>
<tr>
<td>Delay time, CLKOUT high to $\text{IOSTRB}$ high</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$t_{\text{h(A)IOR}}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Hold time, address after CLKOUT low</td>
<td>$0$</td>
<td>$3$</td>
<td>ns</td>
</tr>
</tbody>
</table>

\(^\dagger\) Address and IS timings are included in timings referenced as address.

Figure 15. Parallel I/O Port Read ($\text{IOSTRB} = 0$)
memory and parallel I/O interface timing (continued)

switching characteristics over recommended operating conditions for a parallel I/O port write (\textit{IOSTRB = 0}) [H = 0.5 \( t_{c(CO)} \)]† (see Figure 16)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_d(CLKL-A) )</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_d(CLKH\text{-ISTRBL}) )</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_d(CLKH-D)\text{IOW} )</td>
<td>H−5</td>
<td>H+8</td>
<td>ns</td>
</tr>
<tr>
<td>( t_d(CLKH-ISTRBH) )</td>
<td>−2</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_d(CLKL-RWL) )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_d(CLKL-RWH) )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_h(A)\text{IOW} )</td>
<td>0</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_h(D)\text{IOW} )</td>
<td>H−3</td>
<td>H+7</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su(D)}\text{IOSTRBH} )</td>
<td>H−7</td>
<td>H+1</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su(A)}\text{IOSTRBL} )</td>
<td>H−2</td>
<td>H+2</td>
<td>ns</td>
</tr>
</tbody>
</table>

† Address and IS timings are included in timings referenced as address.

NOTE A: \( A[19:16] \) are always driven low during accesses to I/O space.

Figure 16. Parallel I/O Port Write (\textit{IOSTRB = 0})
ready timing for externally generated wait states

Timing requirements for externally generated wait states \([H = 0.5 t_C(O)\)](see Figure 17, Figure 18, Figure 19, and Figure 20)

<table>
<thead>
<tr>
<th></th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(t_{su}(RDY)) Setup time, READY before CLKOUT low</td>
<td>6</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>(t_{h}(RDY)) Hold time, READY after CLKOUT low</td>
<td>0</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>(t_v(RDY)MSTRB) Valid time, READY after MSTRB low(\dagger)</td>
<td></td>
<td>4H−8</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{h}(RDY)MSTRB) Hold time, READY after MSTRB low(\dagger)</td>
<td></td>
<td>4H</td>
<td>ns</td>
</tr>
<tr>
<td>(t_v(RDY)IOSTRB) Valid time, READY after IOSTRB low(\dagger)</td>
<td></td>
<td>5H−8</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{h}(RDY)IOSTRB) Hold time, READY after IOSTRB low(\dagger)</td>
<td></td>
<td>5H</td>
<td>ns</td>
</tr>
<tr>
<td>(t_v(MSCL)) Valid time, MSC low after CLKOUT low</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>(t_v(MSCH)) Valid time, MSC high after CLKOUT low</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
</tbody>
</table>

\(\dagger\) The hardware wait states can be used only in conjunction with the software wait states to extend the bus cycles. To generate wait states using READY, at least two software wait states must be programmed.

\(\dagger\) These timings are included for reference only. The critical timings for READY are those referenced to CLKOUT.

**Figure 17. Memory Read With Externally Generated Wait States**

NOTE A: \([A19:16]\) are always driven low during accesses to external data space.
ready timing for externally generated wait states (continued)

NOTE A: $A[19:16]$ are always driven low during accesses to external data space.

Figure 18. Memory Write With Externally Generated Wait States
ready timing for externally generated wait states (continued)


Figure 19. I/O Read With Externally Generated Wait States
ready timing for externally generated wait states (continued)


Figure 20. I/O Write With Externally Generated Wait States
HOLD and HOLDA timings

timing requirements for memory control signals and HOLDA, [H = 0.5 \( t_{c(CO)} \)] (see Figure 21)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{w(HOLD)} )</td>
<td>Pulse duration, HOLD low</td>
<td>4H+7</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su(HOLD)} )</td>
<td>Setup time, HOLD low/high before CLKOUT low</td>
<td>7</td>
<td>ns</td>
</tr>
</tbody>
</table>

switching characteristics over recommended operating conditions for memory control signals and HOLDA, [H = 0.5 \( t_{c(CO)} \)] (see Figure 21)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{dis(CLKL-A)} )</td>
<td>Disable time, address, PS, DS, IS high impedance from CLKOUT low</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{dis(CLKL-RW)} )</td>
<td>Disable time, R/W high impedance from CLKOUT low</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{dis(CLKL-S)} )</td>
<td>Disable time, MSTRB, IOSTRB high impedance from CLKOUT low</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{en(CLKL-A)} )</td>
<td>Enable time, address, PS, DS, IS from CLKOUT low</td>
<td>2H+5</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{en(CLKL-RW)} )</td>
<td>Enable time, R/W enabled from CLKOUT low</td>
<td>2H+5</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{en(CLKL-S)} )</td>
<td>Enable time, MSTRB, IOSTRB enabled from CLKOUT low</td>
<td>2</td>
<td>2H+5</td>
</tr>
<tr>
<td>( t_{v(HOLDA)} )</td>
<td>Valid time, HOLDA low after CLKOUT low</td>
<td>−1</td>
<td>2</td>
</tr>
<tr>
<td>( t_{v(HOLDA)} )</td>
<td>Valid time, HOLDA high after CLKOUT low</td>
<td>−1</td>
<td>2</td>
</tr>
<tr>
<td>( t_{w(HOLDA)} )</td>
<td>Pulse duration, HOLDA low duration</td>
<td>2H−1</td>
<td>ns</td>
</tr>
</tbody>
</table>

Figure 21. HOLD and HOLDA Timings (HM = 1)
reset, BIO, interrupt, and MP/MC timings

Timing requirements for reset, BIO, interrupt, and MP/MC [H = 0.5 t_{c(CO)}] (see Figure 22, Figure 23, and Figure 24)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>MAX</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>t_h(RS)</td>
<td>0</td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>Hold time, RS after CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_h(BIO)</td>
<td>0</td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>Hold time, BIO after CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_h(INT)</td>
<td>0</td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>Hold time, INTn, NMI, after CLKOUT low†</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_h(MPMC)</td>
<td>0</td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>Hold time, MP/MC after CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(RSL)</td>
<td>4H+5</td>
<td>4H+5</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, RS low‡§</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(BIO)S</td>
<td>2H+2</td>
<td>2H+2</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, BIO low, synchronous</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(BIO)A</td>
<td>4H</td>
<td>4H</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, BIO low, asynchronous</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(INTH)S</td>
<td>2H</td>
<td>2H</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, INTn, NMI high (synchronous)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(INTH)A</td>
<td>4H</td>
<td>4H</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, INTn, NMI high (asynchronous)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(INTL)S</td>
<td>2H+2</td>
<td>2H+2</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, INTn, NMI low (synchronous)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(INTL)A</td>
<td>4H</td>
<td>4H</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, INTn, NMI low (asynchronous)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_w(INTL)WKP</td>
<td>10</td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>Pulse duration, INTn, NMI low for IDLE2/IDLE3 wakeup</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_su(RS)</td>
<td>5</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>Setup time, RS before X2/CLKIN low¶</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_su(BIO)</td>
<td>7</td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>Setup time, BIO before CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_su(INT)</td>
<td>7</td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>Setup time, INTn, NMI, RS before CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_su(MPMC)</td>
<td>5</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>Setup time, MP/MC before CLKOUT low</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

† The external interrupts (INT0–INT3, NMI) are synchronized to the core CPU by way of a two-flip-flop synchronizer which samples these inputs with consecutive falling edges of CLKOUT. The input to the interrupt pins is required to represent a 1-0-0 sequence at the timing that is corresponding to three CLKOUT sampling sequences.

‡ If the PLL mode is selected, then at power-on sequence, or at wakeup from IDLE3, RS must be held low for at least 50 µs to ensure synchronization and lock-in of the PLL.

§ Note that RS may cause a change in clock frequency, therefore changing the value of H.

¶ Divide-by-two mode
reset, BIO, interrupt, and MP/MC timings (continued)

Figure 22. Reset and BIO Timings

Figure 23. Interrupt Timing

Figure 24. MP/MC Timing
instruction acquisition (IAQ), interrupt acknowledge (IACK), external flag (XF), and TOUT timings

switching characteristics over recommended operating conditions for IAQ and IACK

\[ H = 0.5 t_{c(CO)} \] (see Figure 25)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{d(CLKL-IAQL)} )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{d(CLKL-IAQH)} )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{d(A)IAQ} )</td>
<td>1</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{d(CLKL-IACKL)} )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{d(CLKL-IACKH)} )</td>
<td>−1</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{d(A)IACK} )</td>
<td>3</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{h(A)IAQ} )</td>
<td>−2</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{h(A)IACK} )</td>
<td>−2</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{w(IAQL)} )</td>
<td>2H−2</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{w(IACKL)} )</td>
<td>2H−2</td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

Figure 25. IAQ and IACK Timings
Instruction acquisition (IAQ), interrupt acknowledge (IACK), external flag (XF), and TOUT timings (continued)

Switching characteristics over recommended operating conditions for XF and TOUT [H = 0.5 t\(_{c(CO)}\)] (see Figure 26 and Figure 27)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t(_d)(XF)</td>
<td>Delay time, CLKOUT low to XF high</td>
<td>–1</td>
<td>3</td>
</tr>
<tr>
<td>t(_d)(XF)</td>
<td>Delay time, CLKOUT low to XF low</td>
<td>–1</td>
<td>3</td>
</tr>
<tr>
<td>t(_d)(TOUTH)</td>
<td>Delay time, CLKOUT low to TOUT high</td>
<td>0</td>
<td>4</td>
</tr>
<tr>
<td>t(_d)(TOULT)</td>
<td>Delay time, CLKOUT low to TOUT low</td>
<td>0</td>
<td>4</td>
</tr>
<tr>
<td>t(_w)(TOUT)</td>
<td>Pulse duration, TOUT</td>
<td>2H</td>
<td>ns</td>
</tr>
</tbody>
</table>

Figure 26. XF Timing

Figure 27. TOUT Timing
multichannel buffered serial port timing

### timing requirements for McBSP \([H=0.5t_{c(CO)}]\)† (see Figure 28 and Figure 29)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(t_{c}(BCKRX))</td>
<td>Cycle time, BCLKR/X</td>
<td>BCLKR/X ext</td>
<td>4H</td>
</tr>
<tr>
<td>(t_{w}(BCKRX))</td>
<td>Pulse duration, BCLKR/X high or BCLKR/X low</td>
<td>BCLKR/X ext</td>
<td>2H–2</td>
</tr>
<tr>
<td>(t_{su}(BFRH-BCKRL))</td>
<td>Setup time, external BFSR high before BCLKR low</td>
<td>BCLKR int</td>
<td>8</td>
</tr>
<tr>
<td>(t_{H}(BCKRL-BFRH))</td>
<td>Hold time, external BFSR high after BCLKR low</td>
<td>BCLKR int</td>
<td>0</td>
</tr>
<tr>
<td>(t_{su}(BDRV-BCKRL))</td>
<td>Setup time, BDR valid before BCLKR low</td>
<td>BCLKR int</td>
<td>5</td>
</tr>
<tr>
<td>(t_{H}(BCKRL-BDRV))</td>
<td>Hold time, BDR valid after BCLKR low</td>
<td>BCLKR int</td>
<td>0</td>
</tr>
<tr>
<td>(t_{su}(BFXH-BCKXL))</td>
<td>Setup time, external BFSX high before BCLKX low</td>
<td>BCLKX int</td>
<td>7</td>
</tr>
<tr>
<td>(t_{H}(BCKXL-BFXH))</td>
<td>Hold time, external BFSX high after BCLKX low</td>
<td>BCLKX int</td>
<td>0</td>
</tr>
<tr>
<td>(t_{r}(BCKRX))</td>
<td>Rise time, BCKRX</td>
<td>BCLKR/X ext</td>
<td>8</td>
</tr>
<tr>
<td>(t_{f}(BCKRX))</td>
<td>Fall time, BCKRX</td>
<td>BCLKR/X ext</td>
<td>8</td>
</tr>
</tbody>
</table>

† \(\text{CLKRP} = \text{CLKXP} = \text{FSRP} = \text{FSXP} = 0\). If the polarity of any of the signals is inverted, then the timing references of that signal are also inverted.

### switching characteristics for McBSP \([H=0.5t_{c(CO)}]\)† (see Figure 28 and Figure 29)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(t_{c}(BCKRX))</td>
<td>Cycle time, BCLKR/X</td>
<td>BCLKR/X int</td>
<td>4H</td>
</tr>
<tr>
<td>(t_{w}(BCKRXH))</td>
<td>Pulse duration, BCLKR/X high</td>
<td>BCLKR/X int</td>
<td>D – 2†</td>
</tr>
<tr>
<td>(t_{w}(BCKRXL))</td>
<td>Pulse duration, BCLKR/X low</td>
<td>BCLKR/X int</td>
<td>C + 2†</td>
</tr>
<tr>
<td>(t_{d}(BCKRH-BFRV))</td>
<td>Delay time, BCLKR high to internal BFSR valid</td>
<td>BCLKR int</td>
<td>–2</td>
</tr>
<tr>
<td>(t_{d}(BCKKXH-BFXV))</td>
<td>Delay time, BCLKX high to internal BFSX valid</td>
<td>BCLKX int</td>
<td>0</td>
</tr>
<tr>
<td>(t_{d}(BCKRH-BDXHZ))</td>
<td>Disable time, BCLKX high to BDX high impedance following last data bit of transfer</td>
<td>BCLKX int</td>
<td>–1</td>
</tr>
<tr>
<td>(t_{d}(BCKKXH-BDXV))</td>
<td>Delay time, BCLKX high to BDX valid</td>
<td>BCLKX int</td>
<td>0</td>
</tr>
<tr>
<td>(t_{d}(BFXH-BDXV))</td>
<td>Delay time, BFSX high to BDX valid</td>
<td>BFSX int</td>
<td>–1</td>
</tr>
</tbody>
</table>

† \(\text{CLKRP} = \text{CLKXP} = \text{FSRP} = \text{FSXP} = 0\). If the polarity of any of the signals is inverted, then the timing references of that signal are also inverted.

‡ \(T = \text{BCLKRX period} = (1 + \text{CLKGDV}) \times 2H\)

\(C = \text{BCLKRX low pulse width} = T/2 \text{ when } \text{CLKGDV} \text{ is odd or zero and } = (\text{CLKGDV}/2) \times 2H \text{ when } \text{CLKGDV} \text{ is even}\)

\(D = \text{BCLKRX high pulse width} = T/2 \text{ when } \text{CLKGDV} \text{ is odd or zero and } = (\text{CLKGDV}/2 + 1) \times 2H \text{ when } \text{CLKGDV} \text{ is even}\)

§ The transmit delay enable (DXENA) and A–bis mode (ABIS) features of the McBSP are not implemented on the TMS320VC5402.

¶ Minimum delay times also represent minimum output hold times.
multichannel buffered serial port timing (continued)

Figure 28. McBSP Receive Timings

Figure 29. McBSP Transmit Timings
multichannel buffered serial port timing (continued)

timing requirements for McBSP general-purpose I/O (see Figure 30)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$t_{su}(\text{BGPIO-COH})$</td>
<td>9</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{h}(\text{COH-BGPIO})$</td>
<td>0</td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

† BGPIOx refers to BCLKRx, BFSRx, BDRx, BCLKXx, or BFSXx when configured as a general-purpose input.

switching characteristics for McBSP general-purpose I/O (see Figure 30)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$t_{d}(\text{COH-BGPIO})$</td>
<td>0</td>
<td>5</td>
<td>ns</td>
</tr>
</tbody>
</table>

‡ BGPIOx refers to BCLKRx, BFSRx, BCLKXx, BFSXx, or BDxx when configured as a general-purpose output.

Figure 30. McBSP General-Purpose I/O Timings
multichannel buffered serial port timing (continued)

**timing requirements for McBSP as SPI master or slave:** $[H=0.5t_c(\text{CO})]$ \( \text{CLKSTP} = 10b, \text{CLKXP} = 0 \)

(see Figure 31)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MASTER</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{\text{su}}(\text{BDRV-BCKXL}) )</td>
<td>Setup time, BDR valid before BCLKX low</td>
<td>9</td>
<td>−12H</td>
</tr>
<tr>
<td>( t_{\text{h}}(\text{BCKXL-BDRV}) )</td>
<td>Hold time, BDR valid after BCLKX low</td>
<td>0</td>
<td>5 + 12H</td>
</tr>
<tr>
<td>( t_{\text{su}}(\text{BFXL-BCKXH}) )</td>
<td>Setup time, BFSX low before BCLKX high</td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{\text{c}}(\text{BCKX}) )</td>
<td>Cycle time, BCLKX</td>
<td>12H</td>
<td>32H</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting \( \text{CLKSM} = \text{CLKGDV} = 1 \).

**switching characteristics for McBSP as SPI master or slave:** $[H=0.5t_c(\text{CO})]$ \( \text{CLKSTP} = 10b, \text{CLKXP} = 0 \)

(see Figure 31)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MASTER‡</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{\text{h}}(\text{BCKXL-BFXL}) )</td>
<td>Hold time, BFSX low after BCLKX low $§$</td>
<td>( T - 3 )</td>
<td>( T + 4 )</td>
</tr>
<tr>
<td>( t_{\text{d}}(\text{BFXL-BCKXH}) )</td>
<td>Delay time, BFSX low to BCLKX high ¶</td>
<td>( C - 5 )</td>
<td>( C + 3 )</td>
</tr>
<tr>
<td>( t_{\text{d}}(\text{BCKXH-BDXV}) )</td>
<td>Delay time, BCLKX high to BDX valid</td>
<td>( -2 )</td>
<td>( 6 )</td>
</tr>
<tr>
<td>( t_{\text{dis}}(\text{BCKXL-BDXHZ}) )</td>
<td>Disable time, BDX high impedance following last data bit from BCLKX low</td>
<td>( C - 2 )</td>
<td>( C + 3 )</td>
</tr>
<tr>
<td>( t_{\text{dis}}(\text{BFXH-BDXHZ}) )</td>
<td>Disable time, BDX high impedance following last data bit from BFSX high</td>
<td>( 2H + 4 )</td>
<td>( 6H + 17 )</td>
</tr>
<tr>
<td>( t_{\text{d}}(\text{BFXL-BDXV}) )</td>
<td>Delay time, BFSX low to BDX valid</td>
<td>( 4H - 2 )</td>
<td>( 8H + 17 )</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting \( \text{CLKSM} = \text{CLKGDV} = 1 \).  
‡ \( T = \text{BCLKX period} = (1 + \text{CLKGDV}) \times 2H \)  
\( C = \text{BCLKX low pulse width} = T/2 \text{when } \text{CLKGDV} \text{ is odd or zero and } = (\text{CLKGDV}/2) \times 2H \text{ when } \text{CLKGDV} \text{ is even} \)  
§ \( \text{FSRP} = \text{FSXP} = 1 \). As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFRS is inverted before being used internally. 
\( \text{CLKXM} = \text{FSXM} = 1, \text{CLKRM} = \text{FSRM} = 0 \) for master McBSP 
\( \text{CLKXM} = \text{CLKRM} = \text{FSXM} = \text{FSRM} = 0 \) for slave McBSP.  
¶ BFSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (BCLKX).

---

**Figure 31. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 0**
multichannel buffered serial port timing (continued)

timing requirements for McBSP as SPI master or slave: [H=0.5t_c(CO)]  CLKSTP = 11b, CLKXP = 0† (see Figure 32)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>UNIT</th>
<th>MASTER</th>
<th>MIN</th>
<th>MAX</th>
<th>SLAVE</th>
<th>MIN</th>
<th>MAX</th>
</tr>
</thead>
<tbody>
<tr>
<td>t_{su}(BDRV-BCKXH)</td>
<td></td>
<td>Setup time, BDR valid before BCLKX high</td>
<td>12</td>
<td>2 – 12H</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_{h}(BCKXH-BDRV)</td>
<td></td>
<td>Hold time, BDR valid after BCLKX high</td>
<td>4</td>
<td>5 + 12H</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_{su}(BFXL-BCKXH)</td>
<td></td>
<td>Setup time, BFSX low before BCLKX high</td>
<td>10</td>
<td></td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>t_c(BCKX)</td>
<td></td>
<td>Cycle time, BCLKX</td>
<td>12H</td>
<td>32H</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: [H=0.5t_c(CO)]  CLKSTP = 11b, CLKXP = 0† (see Figure 32)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MASTER ‡</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>t_{h}(BCKXL-BFXL)</td>
<td>Hold time, BFSX low after BCLKX low§</td>
<td>C − 3</td>
<td>C + 4</td>
</tr>
<tr>
<td>t_{d}(BFXL-BCKXH)</td>
<td>Delay time, BFSX low to BCLKX high¶</td>
<td>T − 5</td>
<td>T + 3</td>
</tr>
<tr>
<td>t_{d}(BCKXL-BDXV)</td>
<td>Delay time, BCLKX low to BDX valid</td>
<td>−2</td>
<td>6</td>
</tr>
<tr>
<td>t_{dis}(BCKXL-BDXHZ)</td>
<td>Disable time, BDX high impedance following last data bit from BCLKX low</td>
<td>−2</td>
<td>4</td>
</tr>
<tr>
<td>t_{d}(BFXL-BDXV)</td>
<td>Delay time, BFSX low to BDX valid</td>
<td>D − 2</td>
<td>D + 4</td>
</tr>
</tbody>
</table>

‡ T = BCLKX period = (1 + CLKGDV) * 2H
C = BCLKX low pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2) * 2H when CLKGDV is even
D = BCLKX high pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2 + 1) * 2H when CLKGDV is even
§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFRS is inverted before being used internally.
CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP
CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP
¶ BFSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (BCLKX).

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

---

Figure 32. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 0
multichannel buffered serial port timing (continued)

Timing requirements for McBSP as SPI master or slave: 

\[ H = 0.5t_c(CO) \]  

\[ \text{CLKSTP} = 10b, \text{CLKXP} = 1 \]  

(see Figure 33)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MASTER</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{su}(BDRV-BCKXH) )</td>
<td>Setup time, BDR valid before BCLKX high</td>
<td>12</td>
<td>2 – 12H</td>
</tr>
<tr>
<td>( t_h(BCKXH-BDRV) )</td>
<td>Hold time, BDR valid after BCLKX high</td>
<td>4</td>
<td>5 + 12H</td>
</tr>
<tr>
<td>( t_{su}(BFXL-BCKXL) )</td>
<td>Setup time, BFSX low before BCLKX low</td>
<td>10</td>
<td></td>
</tr>
<tr>
<td>( t_c(BCKX) )</td>
<td>Cycle time, BCLKX</td>
<td>12H</td>
<td>32H</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting \( \text{CLKSM} = \text{CLKGDV} = 1 \).

Switching characteristics for McBSP as SPI master or slave: 

\[ H = 0.5t_c(CO) \]  

\[ \text{CLKSTP} = 10b, \text{CLKXP} = 1 \]  

(see Figure 33)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MASTER</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_h(BCKXH-BFXL) )</td>
<td>Hold time, BFSX low after BCLKX high§</td>
<td>( T - 3 )</td>
<td>( T + 4 )</td>
</tr>
<tr>
<td>( t_d(BFXL-BCKXL) )</td>
<td>Delay time, BFSX low to BCLKX low¶</td>
<td>( D - 5 )</td>
<td>( D + 3 )</td>
</tr>
<tr>
<td>( t_d(BCKXL-BDXV) )</td>
<td>Delay time, BCLKX low to BDX valid</td>
<td>–2</td>
<td>6</td>
</tr>
<tr>
<td>( t_{dis}(BCKXH-BDXHZ) )</td>
<td>Disable time, BDX high impedance following last data bit from BCLKX high</td>
<td>( D - 2 )</td>
<td>( D + 3 )</td>
</tr>
<tr>
<td>( t_{dis}(BFXH-BDXHZ) )</td>
<td>Disable time, BDX high impedance following last data bit from BFSX high</td>
<td>( 2H + 3 )</td>
<td>( 6H + 17 )</td>
</tr>
<tr>
<td>( t_d(BFXL-BDXV) )</td>
<td>Delay time, BFSX low to BDX valid</td>
<td>( 4H - 2 )</td>
<td>( 8H + 17 )</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting \( \text{CLKSM} = \text{CLKGDV} = 1 \).

‡ \( T = \) BCLKX period = \((1 + \text{CLKGDV}) \times 2H\)

\( D = \) BCLKX high pulse width = \(T/2\) when \(\text{CLKGDV}\) is odd or zero and = \((\text{CLKGDV}/2 + 1) \times 2H\) when \(\text{CLKGDV}\) is even

§ \( FSRP = FSXP = 1 \). As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFRS is inverted before being used internally.

\( \text{CLKXM} = \text{FSXM} = 1, \text{CLKRM} = \text{FSRM} = 0 \) for master McBSP

\( \text{CLKXM} = \text{CLKRM} = \text{FSXM} = \text{FSRM} = 0 \) for slave McBSP

¶ BFSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (BCLKX).

---

Figure 33. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 1
multichannel buffered serial port timing (continued)

timing requirements for McBSP as SPI master or slave: \([H=0.5t_{c(CO)}]\) CLKSTP = 11b, CLKXP = 1† (see Figure 34)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MASTER</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(t_{su}(BDRV-BCKXL))</td>
<td>(\min) (9)</td>
<td>(\max) (-12H)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{h}(BCKXL-BDRV))</td>
<td>(\min) (0)</td>
<td>(\max) (5 + 12H)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{su}(BFXL-BCKXL))</td>
<td>(\min) (10)</td>
<td>(\max) ns</td>
<td></td>
</tr>
<tr>
<td>(t_{c}(BCKX))</td>
<td>(\min) (12H)</td>
<td>(\max) (32H)</td>
<td>ns</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: \([H=0.5t_{c(CO)}]\) CLKSTP = 11b, CLKXP = 1†‡ (see Figure 34)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MASTER ‡</th>
<th>SLAVE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(t_{h}(BCKXH-BFXL))</td>
<td>(\min) (D - 3)</td>
<td>(\max) (D + 4)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{d}(BFXL-BCKXL))</td>
<td>(\min) (T - 5)</td>
<td>(\max) (T + 3)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{d}(BCKXH-BDXV))</td>
<td>(\min) (-2)</td>
<td>(\max) (6)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{dis}(BCKXH-BDXHZ))</td>
<td>(\min) (-2)</td>
<td>(\max) (6H + 5)</td>
<td>ns</td>
</tr>
<tr>
<td>(t_{d}(BFXL-BDXV))</td>
<td>(\min) (C - 2)</td>
<td>(\max) (C + 4)</td>
<td>ns</td>
</tr>
</tbody>
</table>

† For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.
‡ \(T = BCLKX \text{ period} = (1 + \text{CLKGDV}) \times 2H\)
… C = BCLKX low pulse width = \(T/2\) when CLKGDV is odd or zero and = \((\text{CLKGDV}/2) \times 2H\) when CLKGDV is even
… D = BCLKX high pulse width = \(T/2\) when CLKGDV is odd or zero and = \((\text{CLKGDV}/2 + 1) \times 2H\) when CLKGDV is even
§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFRS is inverted before being used internally.
… CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP
… CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP
… BFSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (BCLKX).

Figure 34. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 1
HPI8 timing

switching characteristics over recommended operating conditions†‡§¶ [H = 0.5tc(CO)]
(see Figure 35, Figure 36, Figure 37, and Figure 38)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>ten(DSL-HD)</td>
<td>Enable time, HD driven from DS low</td>
<td>2</td>
<td>16</td>
</tr>
<tr>
<td>td(DSL-HDV1)</td>
<td>Delay time, DS low to HDx valid for first byte of an HPI read</td>
<td>18H+16 – tw(DSH)</td>
<td>ns</td>
</tr>
<tr>
<td>td(DSL-HDV2)</td>
<td>Delay time, DS low to HDx valid for second byte of an HPI read</td>
<td>16</td>
<td>ns</td>
</tr>
<tr>
<td>th(DSH-HDV)</td>
<td>Hold time, HDx valid after DS high, for a HPI read</td>
<td>3</td>
<td>5</td>
</tr>
<tr>
<td>tv(HYH-HDV)</td>
<td>Valid time, HDx valid after HRDY high</td>
<td>9</td>
<td></td>
</tr>
<tr>
<td>td(DSH-HYL)</td>
<td>Delay time, DS high to HRDY low (see Note 1)</td>
<td>16</td>
<td>ns</td>
</tr>
<tr>
<td>td(DSH-HYH)</td>
<td>Delay time, DS high to HRDY high</td>
<td>Case 1a: Memory accesses when DMAC is active in 16-bit mode and ( tw(DSH) &lt; 18H )</td>
<td>18H+16</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 1b: Memory accesses when DMAC is active in 16-bit mode and ( tw(DSH) \geq 18H )</td>
<td>16</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 1c: Memory access when DMAC is active in 32-bit mode and ( tw(DSH) &lt; 26H )</td>
<td>26H+16 – tw(DSH)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 1d: Memory access when DMAC is active in 32-bit mode and ( tw(DSH) \geq 26H )</td>
<td>16</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 2a: Memory accesses when DMAC is inactive and ( tw(DSH) &lt; 10H )</td>
<td>10H+16 – tw(DSH)</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 2b: Memory accesses when DMAC is inactive and ( tw(DSH) \geq 10H )</td>
<td>16</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Case 3: Register accesses</td>
<td>16</td>
</tr>
<tr>
<td>td(HCS-HRDY)</td>
<td>Delay time, HCS low/high to HRDY low/high</td>
<td>6H+16</td>
<td>ns</td>
</tr>
<tr>
<td>td(COH-HYH)</td>
<td>Delay time, CLKOUT high to HRDY high</td>
<td>3</td>
<td>ns</td>
</tr>
<tr>
<td>td(COH-HTX)</td>
<td>Delay time, CLKOUT high to HINT change</td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>td(COH-GPIO)</td>
<td>Delay time, CLKOUT high to HDx output change. HDx is configured as a general-purpose output.</td>
<td>6</td>
<td>ns</td>
</tr>
</tbody>
</table>

NOTES:
1. The HRDY output is always high when the HCS input is high, regardless of DS timings.
2. This timing applies when writing a one to the DSPINT bit or HINT bit of the HPIC register. All other writes to the HPIC occur asynchronously, and do not cause HRDY to be deasserted.

† DS refers to the logical OR of HCS, HDS1, and HDS2.
‡ HDx refers to any of the HPI data bus pins (HD0, HD1, HD2, etc.).
§ DMAC stands for direct memory access (DMA) controller. The HPI8 shares the internal DMA bus with the DMAC, thus HPI8 access times are affected by DMAC activity.
¶ GPIO refers to the HD pins when they are configured as general-purpose input/outputs.
HPI8 timing (continued)

timing requirements†‡§ (see Figure 35, Figure 36, Figure 37, and Figure 38)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{su}(HBV-DSL) ) Setup time, HBIL and HAD valid before DS low or before HAS low¶#</td>
<td>5</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{h}(DSL-HBV) ) Hold time, HBIL and HAD valid after DS low or after HAS low¶#</td>
<td>5</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su}(HSL-DSL) ) Setup time, HAS low before DS low</td>
<td>10</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{w}(DSL) ) Pulse duration, DS low</td>
<td>20</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{w}(DSH) ) Pulse duration, DS high</td>
<td>10</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su}(HDV-DSH) ) Setup time, HDx valid before DS high, HPI write</td>
<td>2</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{h}(DSH-HDV) ) Hold time, HDx valid after DS high, HPI write</td>
<td>3</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{su}(GPIO-COH) ) Setup time, HDx input valid before CLKOUT high, HDx configured as general-purpose input</td>
<td>6</td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>( t_{h}(GPIO-COH) ) Hold time, HDx input valid after CLKOUT high, HDx configured as general-purpose input</td>
<td>0</td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

† DS refers to the logical OR of HCS, HDS1, and HDS2.
‡ HDx refers to any of the HPI data bus pins (HD0, HD1, HD2, etc.).
§ GPIO refers to the HD pins when they are configured as general-purpose input/outputs.
¶ HAD refers to HCNTL0, HCNTL1, and H/RW.
# When the HAS signal is used to latch the control signals, this timing refers to the falling edge of the HAS signal. Otherwise, when HAS is not used (always high), this timing refers to the falling edge of DS.
HPI8 timing (continued)

Figure 35. Using HDS to Control Accesses (HCS Always Low)

† HAD refers to HCNTL0, HCNTL1, and HR/W.
‡ When HAS is not used (HAS always high)
HPI8 timing (continued)

![Diagram of HCS, HDS, and HRDY]

Figure 36. Using HCS to Control Accesses

![Diagram of CLKOUT, HINT, and GPIOx timings]

Figure 37. HINT Timing

![Diagram of CLKOUT, GPIOx Input Mode, and GPIOx Output Mode timings]

Figure 38. GPIOx† Timings

† GPIOx refers to HD0, HD1, HD2, ...HD7, when the HD bus is configured for general-purpose input/output (I/O).
The following packaging information reflects the most current released data available for the designated device(s). This data is subject to change without notice and without revision of this document.

**package thermal resistance characteristics**

Table 1 provides the estimated thermal resistance characteristics for the recommended package types used on the device.

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>PGE PACKAGE</th>
<th>GGU PACKAGE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$R_{θJA}$</td>
<td>56</td>
<td>38</td>
<td>°C/W</td>
</tr>
<tr>
<td>$R_{θJC}$</td>
<td>5</td>
<td>5</td>
<td>°C/W</td>
</tr>
</tbody>
</table>
# PACKAGING INFORMATION

<table>
<thead>
<tr>
<th>Orderable Device</th>
<th>Status (1)</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan (2)</th>
<th>Lead/Ball Finish (6)</th>
<th>MSL Peak Temp (3)</th>
<th>Op Temp (°C)</th>
<th>Device Marking (4/5)</th>
<th>Samples</th>
</tr>
</thead>
<tbody>
<tr>
<td>DSG5402PGE100</td>
<td>ACTIVE</td>
<td>LQFP</td>
<td>PGE</td>
<td>144</td>
<td>60</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>0 to 0</td>
<td>PGE100 TMS320VC5402</td>
<td>Samples</td>
</tr>
<tr>
<td>TMS320VC5402PGE100</td>
<td>ACTIVE</td>
<td>LQFP</td>
<td>PGE</td>
<td>144</td>
<td>60</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>0 to 0</td>
<td>PGE100 TMS320VC5402</td>
<td>Samples</td>
</tr>
<tr>
<td>TMS320VC5402PGER10</td>
<td>ACTIVE</td>
<td>LQFP</td>
<td>PGE</td>
<td>144</td>
<td>500</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-1-260C-UNLIM</td>
<td>0 to 0</td>
<td>PGE100 TMS320VC5402</td>
<td>Samples</td>
</tr>
<tr>
<td>TMS320VC5402ZGU100</td>
<td>NRND</td>
<td>BGA</td>
<td>MICROSTAR</td>
<td>144</td>
<td>160</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>SNAGCU</td>
<td>Level-3-260C-168 HR</td>
<td>0 to 0</td>
<td>DVC5402ZGU100</td>
<td>Samples</td>
</tr>
<tr>
<td>TMSDVC5402PGE100G4</td>
<td>ACTIVE</td>
<td>LQFP</td>
<td>PGE</td>
<td>144</td>
<td>60</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>0 to 0</td>
<td>PGE100 TMS320VC5402</td>
<td>Samples</td>
</tr>
</tbody>
</table>

(1) The marketing status values are defined as follows:

- **ACTIVE**: Product device recommended for new designs.
- **LIFEBUY**: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
- **NRND**: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
- **PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.
- **OBSOLETE**: TI has discontinued the production of the device.

(2) **RoHS**: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substances do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

- **RoHS Exempt**: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
- **Green**: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.
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NOTES:  
A. All linear dimensions are in millimeters.  
B. This drawing is subject to change without notice.  
C. Falls within JEDEC MS-026
ZGU (S–PBGA–N144) PLASTIC BALL GRID ARRAY

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Micro Star BGA configuration
D. This is a lead-free solder ball design.
GGU (S–PBGA–N144)  PLASTIC BALL GRID ARRAY

NOTES:  A. All linear dimensions are in millimeters.
       B. This drawing is subject to change without notice
       C. MicroStar BGA™ configuration

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